

# Beam Instrumentation

## Basic CAS 2021 – Video course

H.Schmickler, CERN



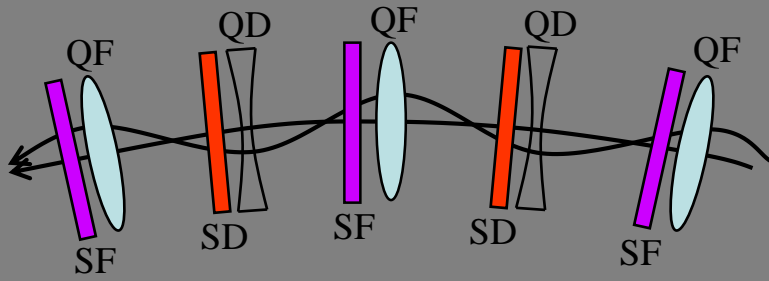
# Introduction

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- **What do we mean by beam instrumentation?**
  - The “eyes” of the machine operators
    - i.e. the instruments that observe beam behaviour
    - “An accelerator can never be better than the instruments measuring its performance!”
- **What does work in beam instrumentation entail?**
  - Design, construction & operation of instruments to observe particle beams
  - R&D to find new or improve existing techniques to fulfill new requirements
  - A combination of the following disciplines
    - Applied & Accelerator Physics; Mechanical, Electronic & Software Engineering
- **What beam parameters do we measure?**
  - Beam Position
    - Horizontal and vertical throughout the accelerator
  - Beam Intensity (& lifetime measurement for a storage ring/collider)
    - Bunch-by-bunch charge and total circulating current
  - Beam Loss
    - Especially important for high brightness and superconducting machines
  - Beam profiles
    - Transverse and longitudinal distribution

# More Measurements

- Machine Tune

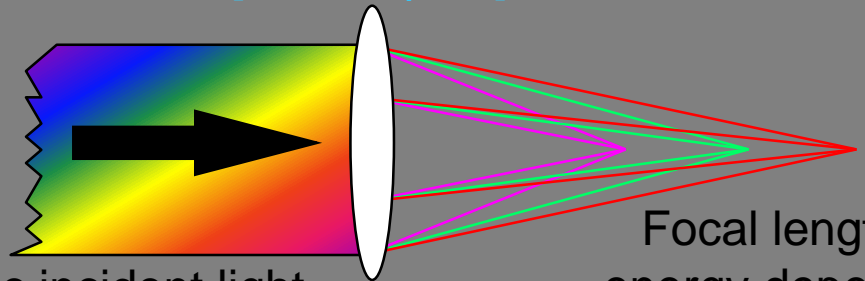


Characteristic Frequency of the Magnetic Lattice Given by the strength of the Quadrupole magnets

- Machine Chromaticity

Optics Analogy:

Lens [Quadrupole]



Spread in the Machine Tune due to Particle Energy Spread Controlled by Sextupole magnets

Achromatic incident light [Spread in particle energy]

Focal length is energy dependent



# Not further treated:

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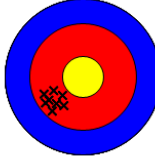

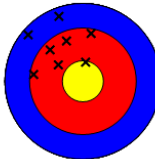
- **Luminosity Measurements**  
(dedicated arrangements close to the IP)
- **Direct Emittance Measurements**  
(simultaneous measurement of size and divergence)
- **Particle identification, Time of flight...**  
(relevant for secondary beam lines)
- **Synchronization,**  
**beam arrival time monitors**  
...this needs a full course on its own

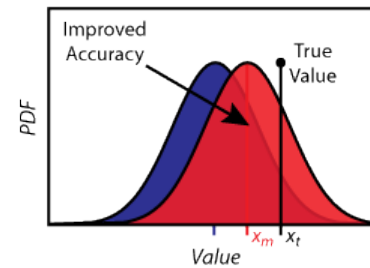
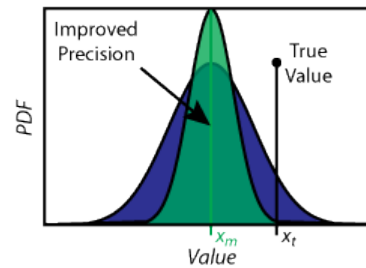
## ....in general...

- In every instrument we
  - intercept information of the particle beam
  - convert it to an electrical signal
  - digitize it and transmit it to the control room
  - display it, use it for the computation of corrections, use it in real-time feedback loops...
  - store it for further analysis
- What can we intercept?
  - the beam particles themselves  
(typical: beam screen, beam loss monitors...)
  - the electromagnetic field of the beam  
(most instruments, important: beam position monitors)
  - light emitted by the beam  
(typical: transverse and longitudinal profiles)

# Accuracy, Precision, Resolution

- Very often confused in day-to-day language
- Accuracy:= also called trueness of measurement
- Precision:= how well can I reproduce my measurements
- Resolution:= smallest possible difference in successive measurements

	Accurate	Inaccurate (systematic error)
Precise		
Imprecise (reproducibility error)		



Ex: BPM: Mechanical and electrical offsets, gain factors influence the accuracy, various noise sources or timing jitter influence the precision, ADC resolution can limit the resolution.



# The Typical Instruments

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- **Beam Intensity**
  - beam current transformers
- **Beam Position**
  - electrostatic or electromagnetic pick-ups and related electronics
- **Beam Profile**
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
  - ionization and luminescence monitors
  - femtosecond diagnostics for ultra short bunches
- **Beam Loss**
  - ionization chambers or pin diodes
- **Machine Tune and Chromaticity (derived quantities)**



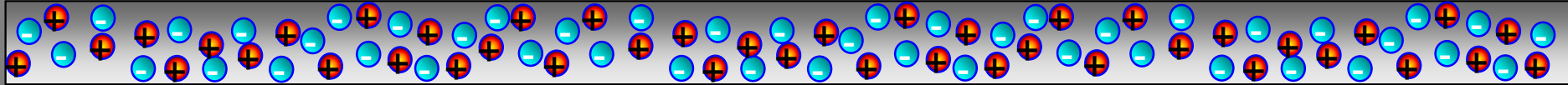
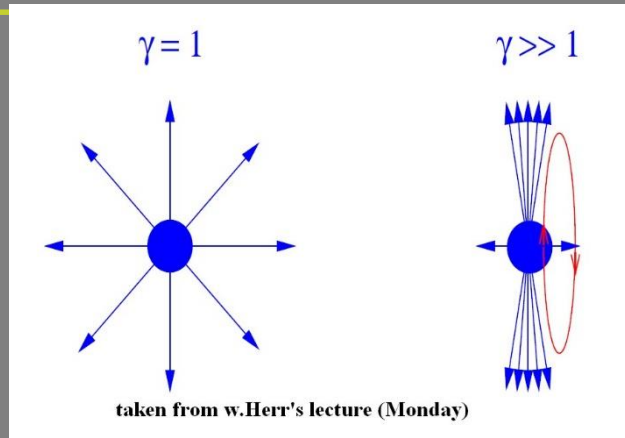
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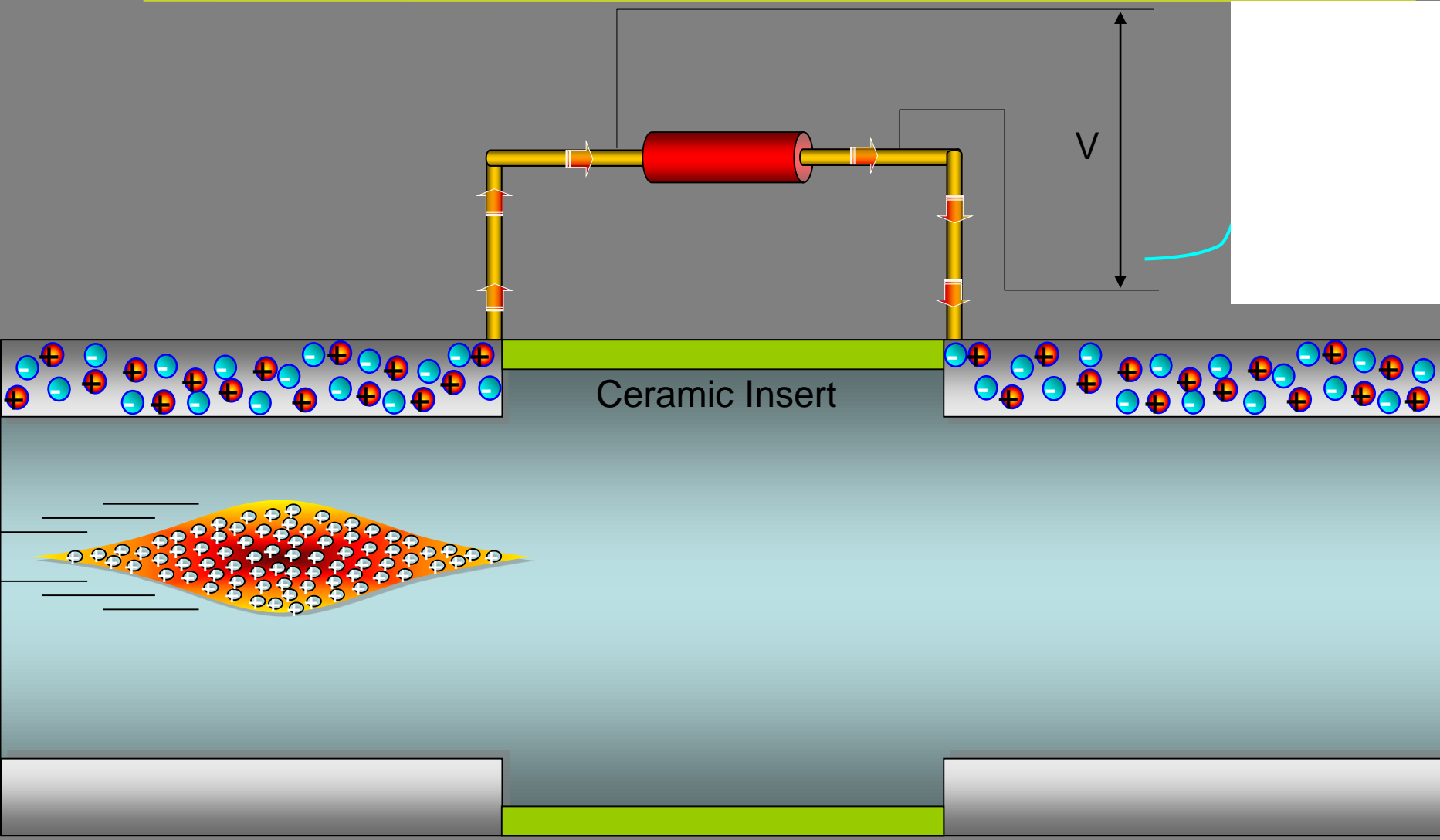


# Beam Image (wall) current– The Principle

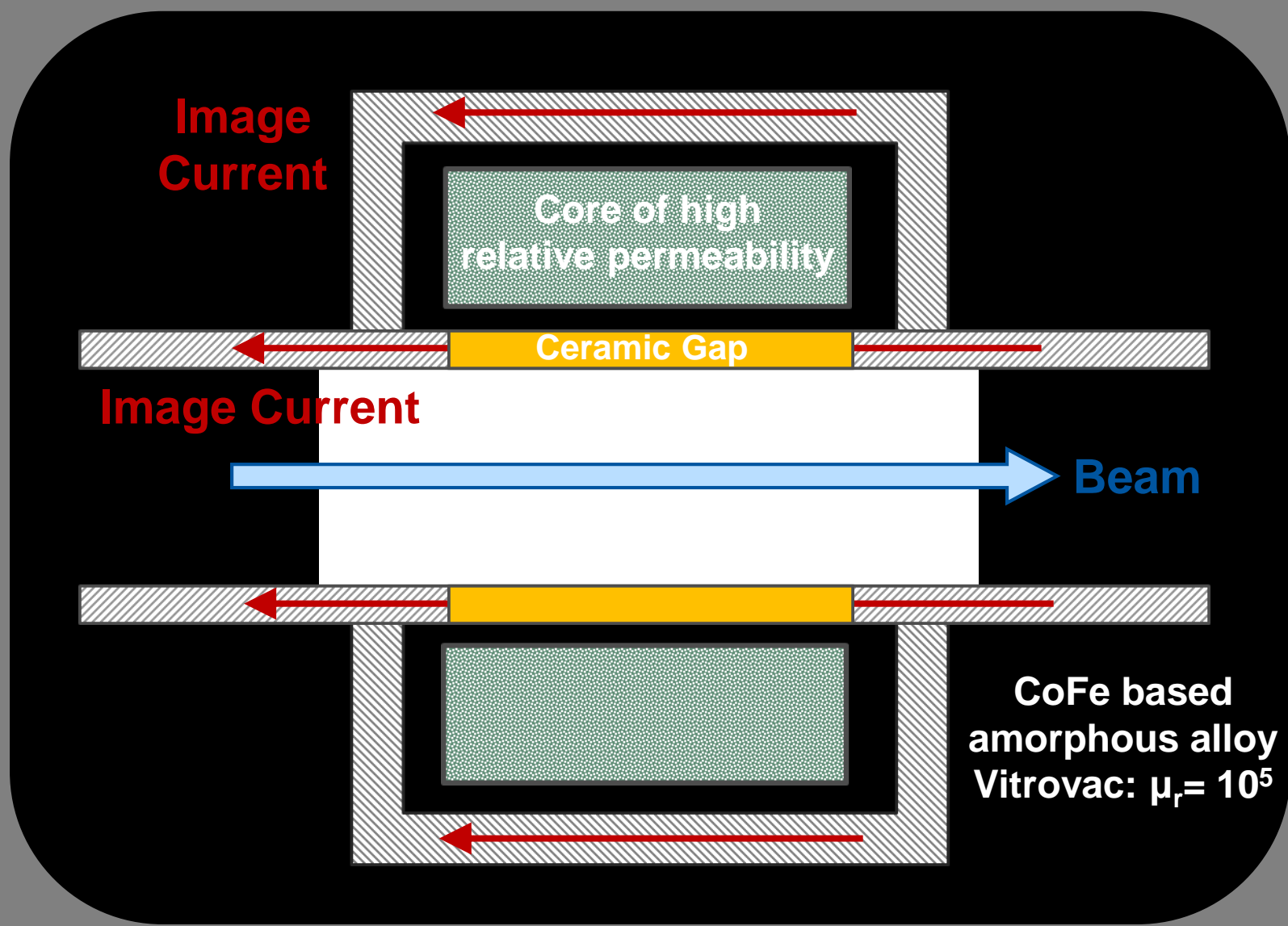




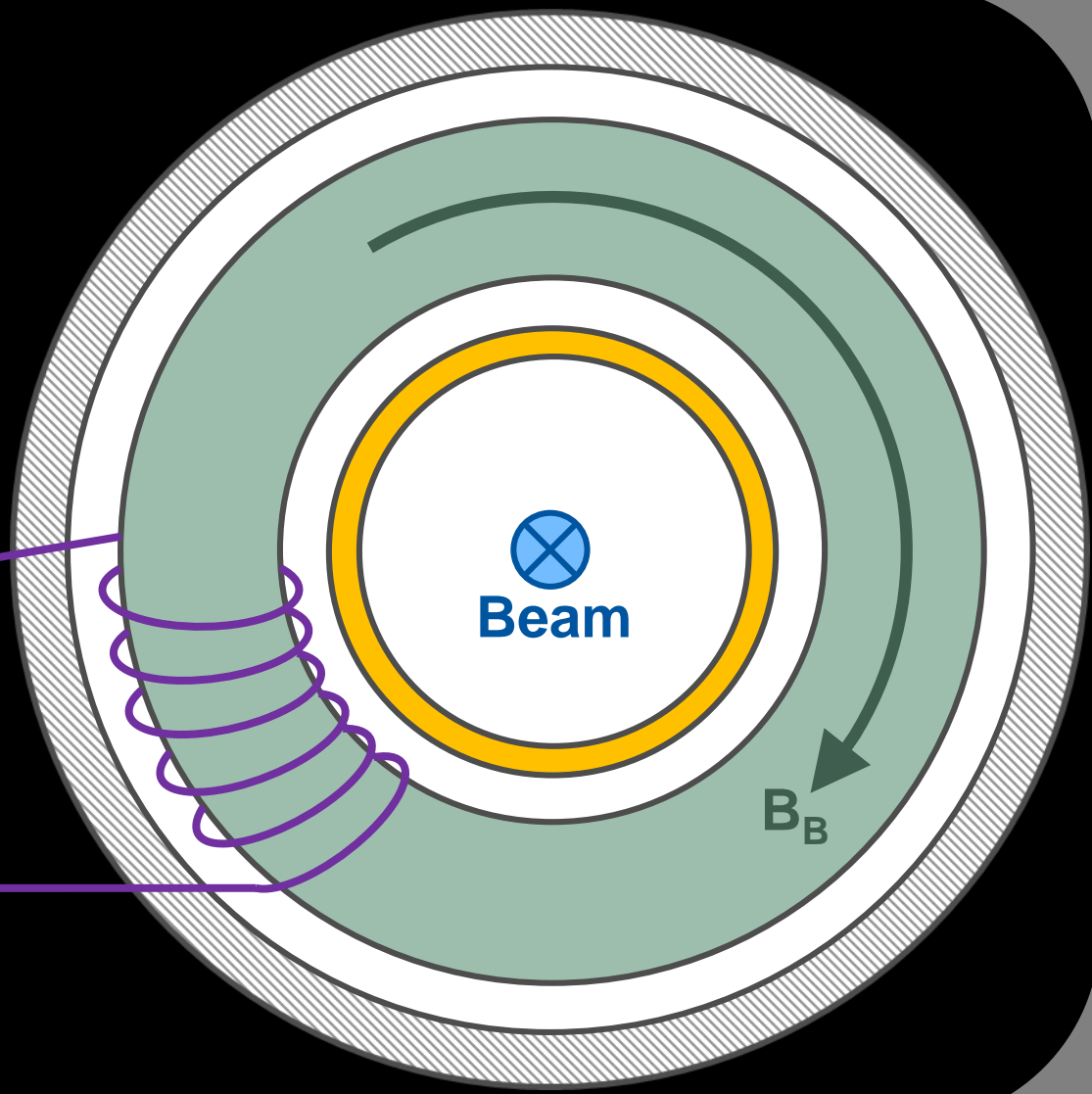
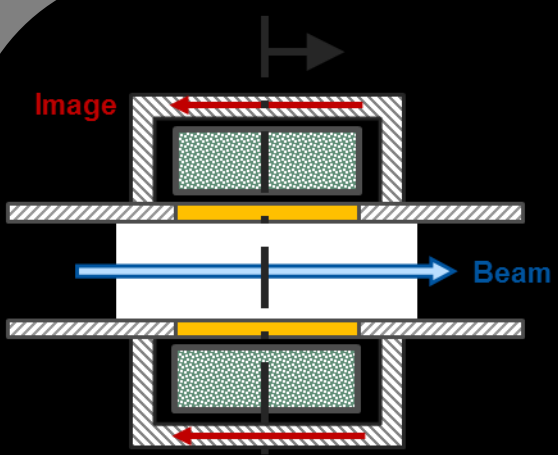
# Wall Current Monitor – The Principle



# AC (Fast) Current Transformers

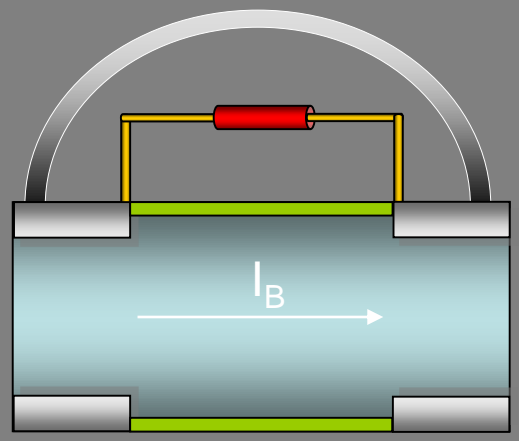
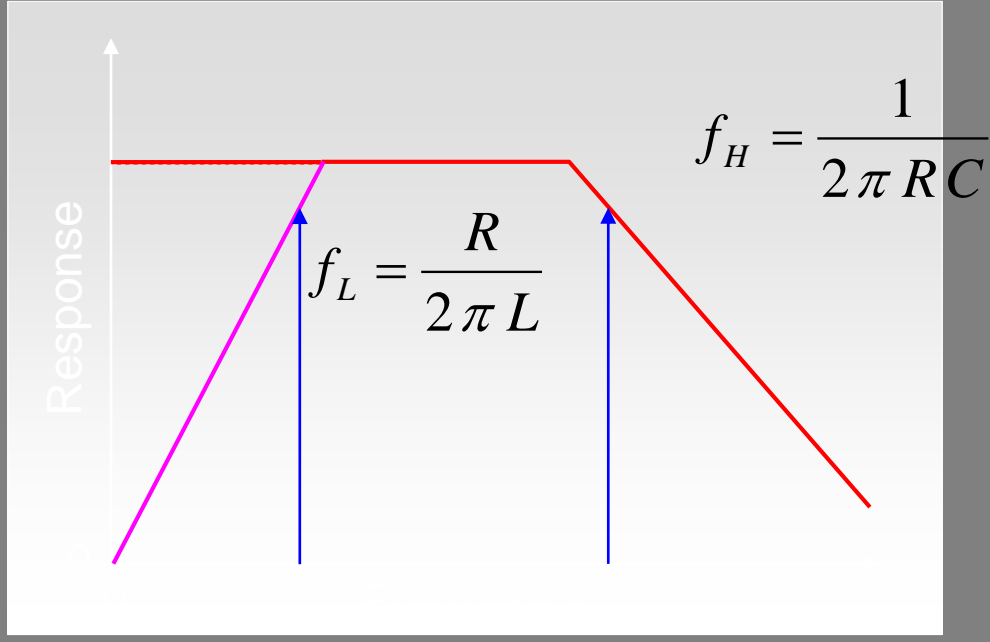
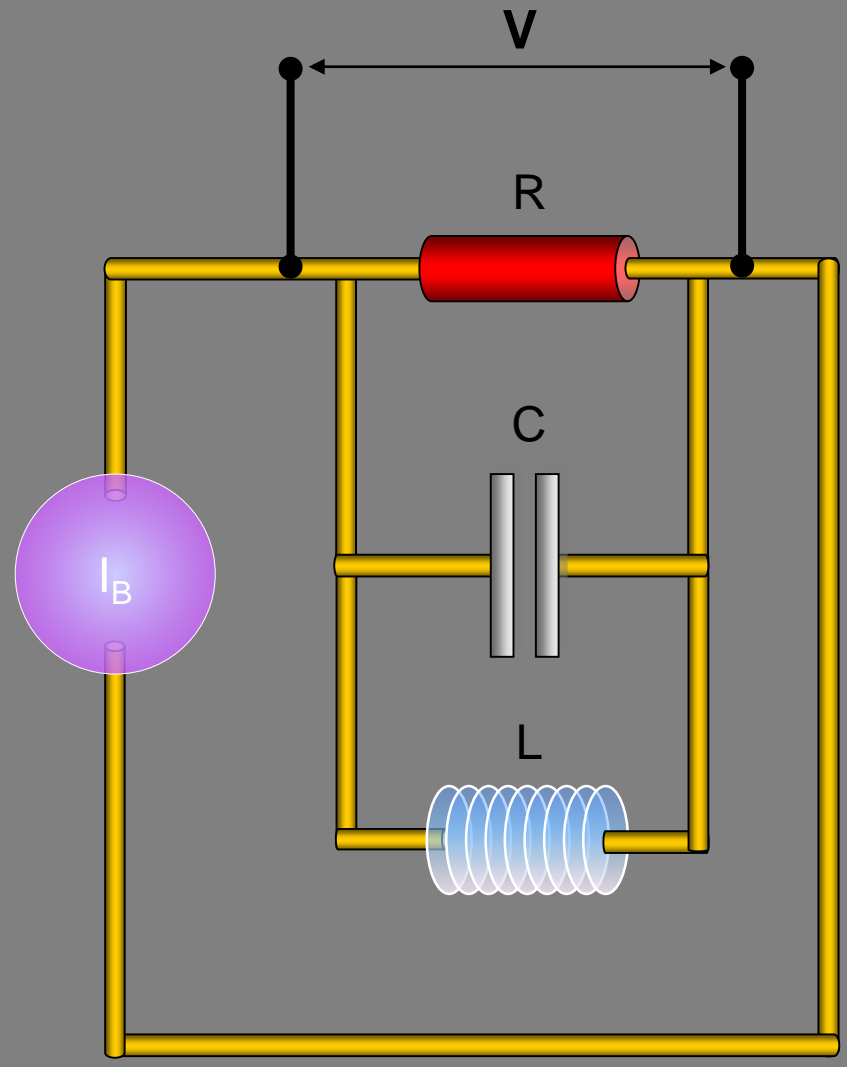


# AC (Fast) Current Transformers





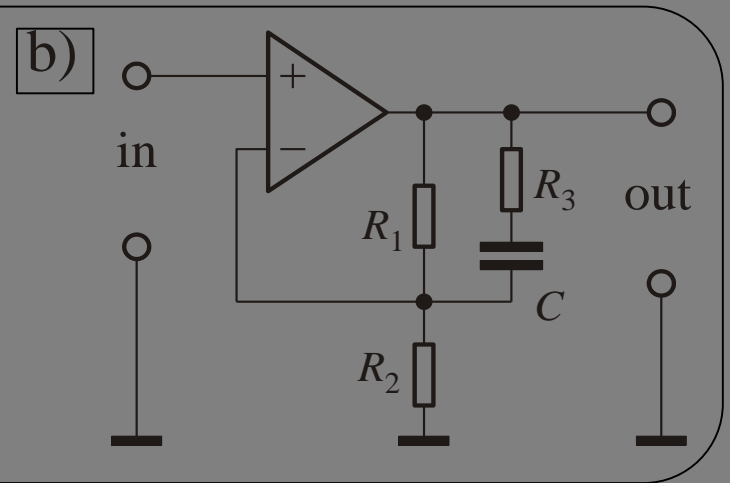
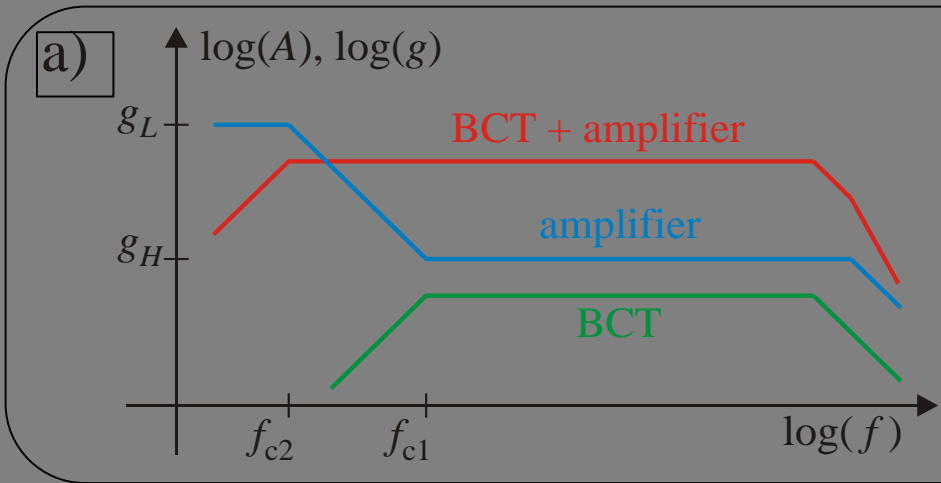
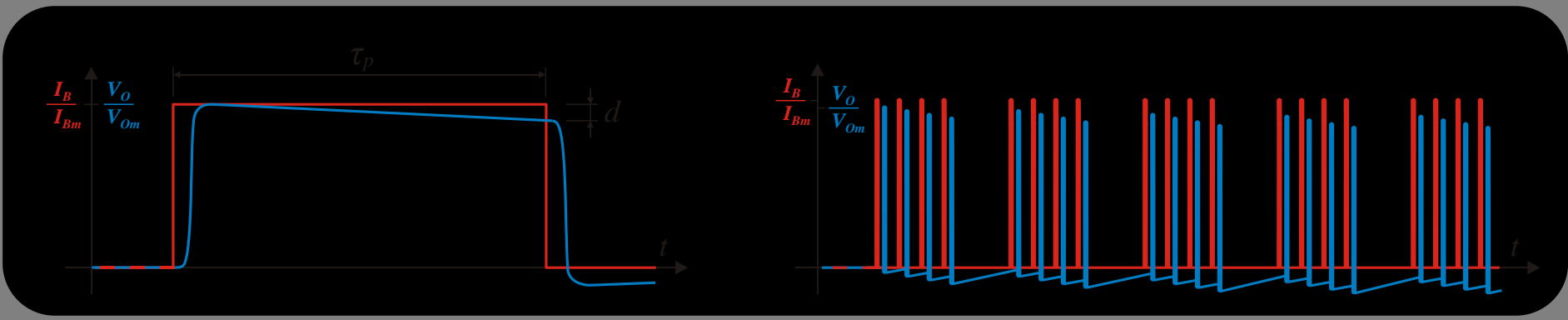
# Wall Current Monitor – Beam Response





# AC (Fast) Transformer Response

- **Low cut-off**
  - Impedance of secondary winding decreases at low frequency
  - Results in signal droop and baseline shift
  - Mitigated by baseline restoration techniques (analogue or digital)





# What one can do with such a System

SPS Bunch to Bunch Position Measurement Interface - FSTBCT-06092002-PROTON2-0ms-MTG#1.txt

File Settings Drawing Options Help

Acquisition: **Multi Acquisition**

Acquisition Time: 0 ms

First Bunch: 1

Number of Bunches: 72

Number of Turns: 1

**Start Acquisition**

**Start Repeat** **Stop Repeat**

Dataviewer Control:

**Batch Evolution**

Trace 1 on Dataviewer: 2, 9 ms

Trace 2 on Dataviewer: 2, 9 ms

Turn on Dataviewer: 1

CERN/SL XDataviewer 6.4 ZOOMIN:Pick first point Kick Clean Reverse

Views Subview External Editor Select

Plot Grid OFF Zeroline OFF OP ONE Zoom In Box

Profiles 06/09/02 17:07:19

Bunch Intensity -3.6 Bunch 74.6

Tum 1

Da 48.0000 0.0056 dy -0.1297 Cu 47.8789 -0.1241 pl\_trace1

**2D View** **3D View** **Dataviewer**

Ready ...

Bad RF Capture of a single LHC Batch in the SPS (72 bunches)



# The Typical Instruments

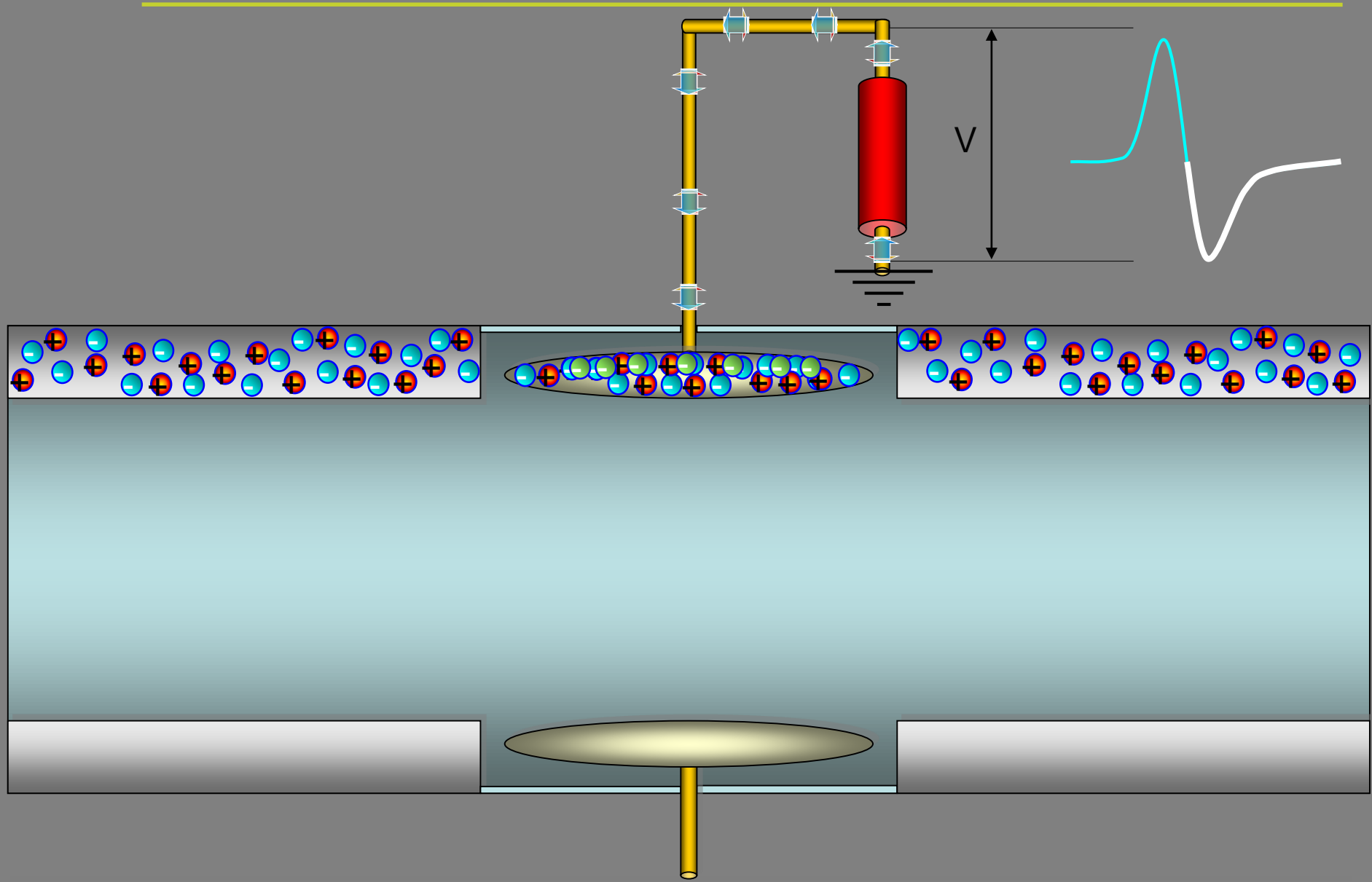
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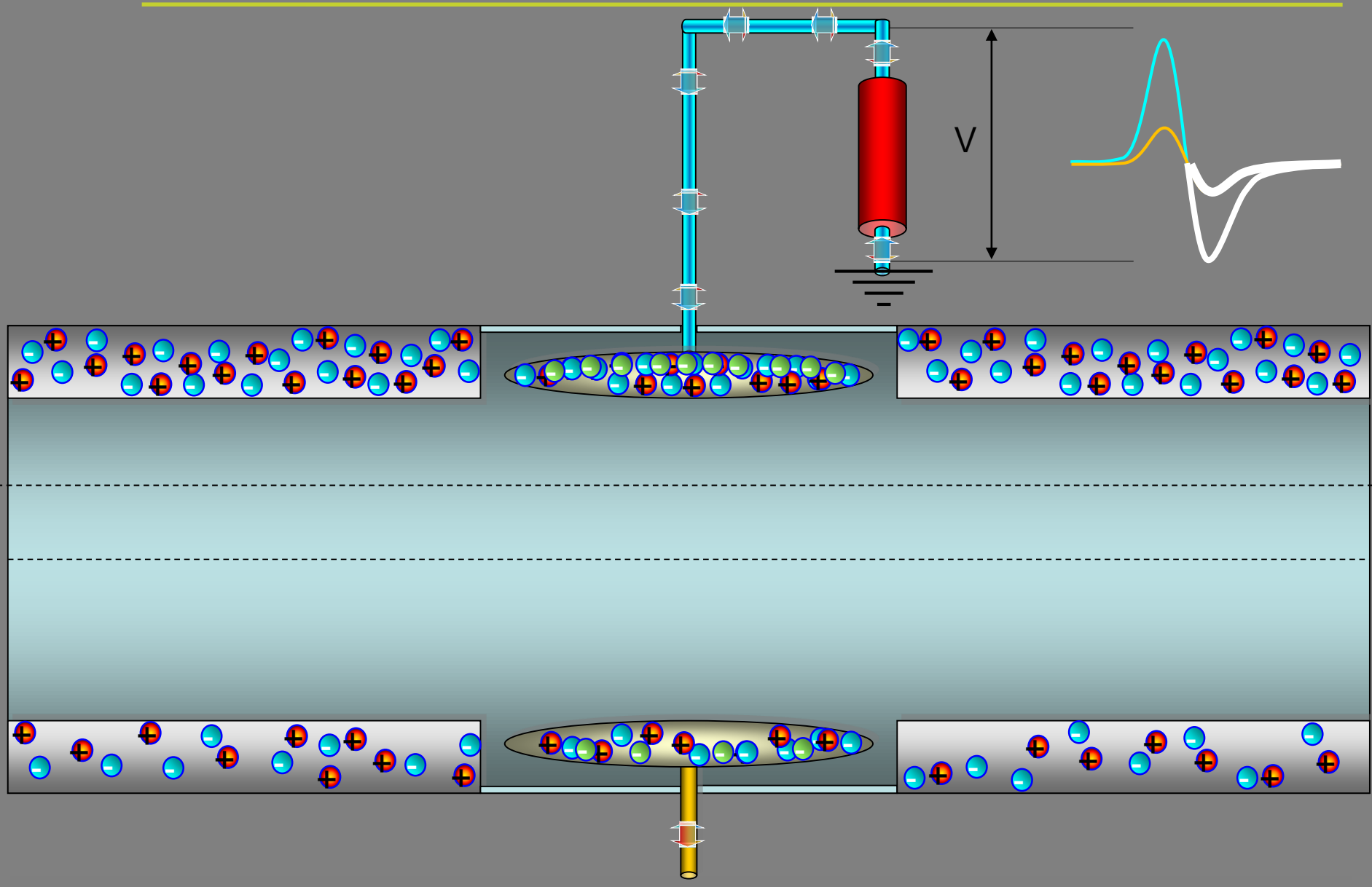


# Electrostatic Monitor – The Principle





# Electrostatic Beam Position Monitor





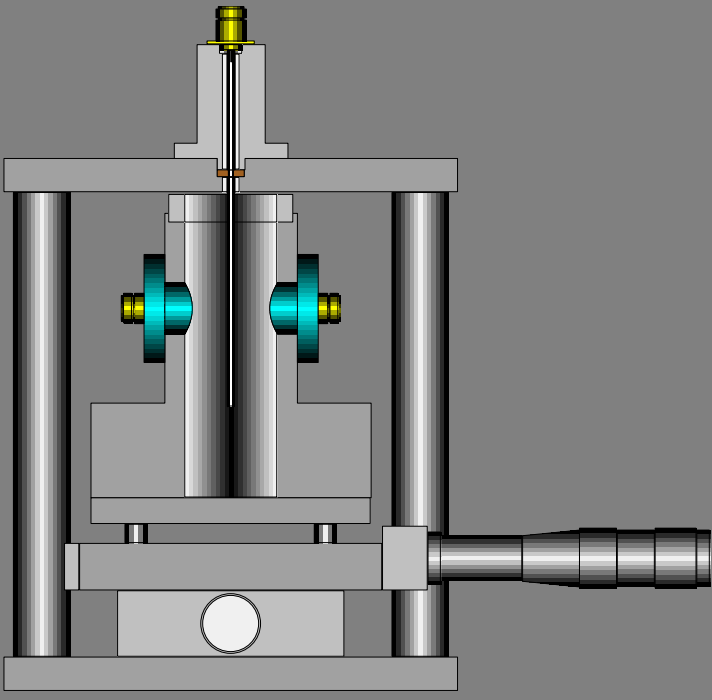
# Principle of Beam Position Monitors

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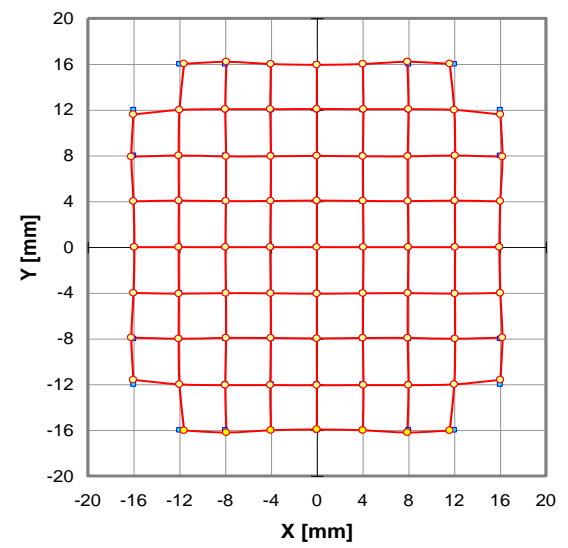
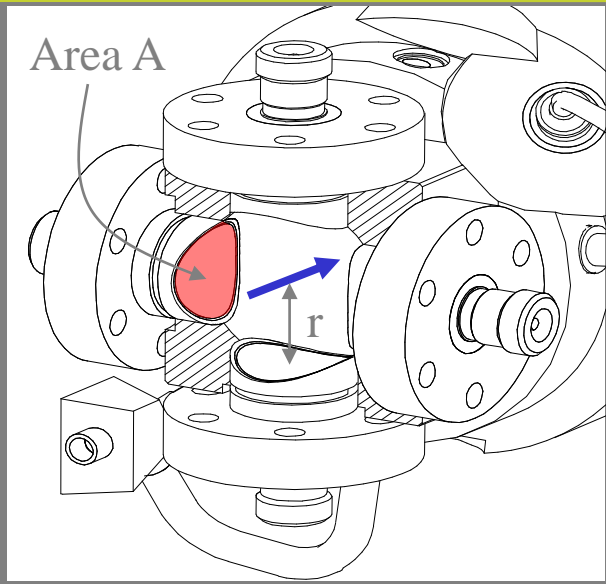
- Intercept “beam image current” in the vacuum chamber on two isolated (capacitive) pickups.
- Other pickups (more involved): shoebox (linear) pickups, stripline directional couplers....
- Use high precision Rf electronics to shape the signals (short bunches deliver signals with high frequency content)
  - amplifiers
  - filters
  - down converters
- Digitize the individual pickup signals
- Eliminate the intensity information from the pickup signals (= “normalization”)
- Compute the position from the pickup-signal difference
- Linearize the pickup response
- Calibrate the system in metric units

# Electrostatic Pick-up – Button

- ✓ Low cost  $\Rightarrow$  most popular
- ✗ Non-linear
  - requires correction algorithm when beam is off-centre



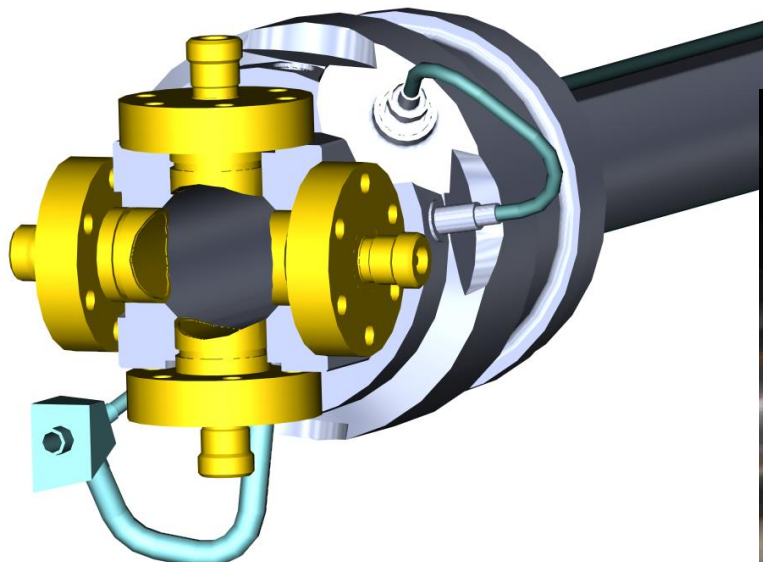
Position mapping with movable antenna



$$X = 2.30 \cdot 10^{-5} X_1^5 + 3.70 \cdot 10^{-5} X_1^3 + 1.035 X_1 + 7.53 \cdot 10^{-6} X_1^3 Y_1^2 + 1.53 \cdot 10^{-5} X_1 Y_1^4$$

## Realization of Button BPM at LHC

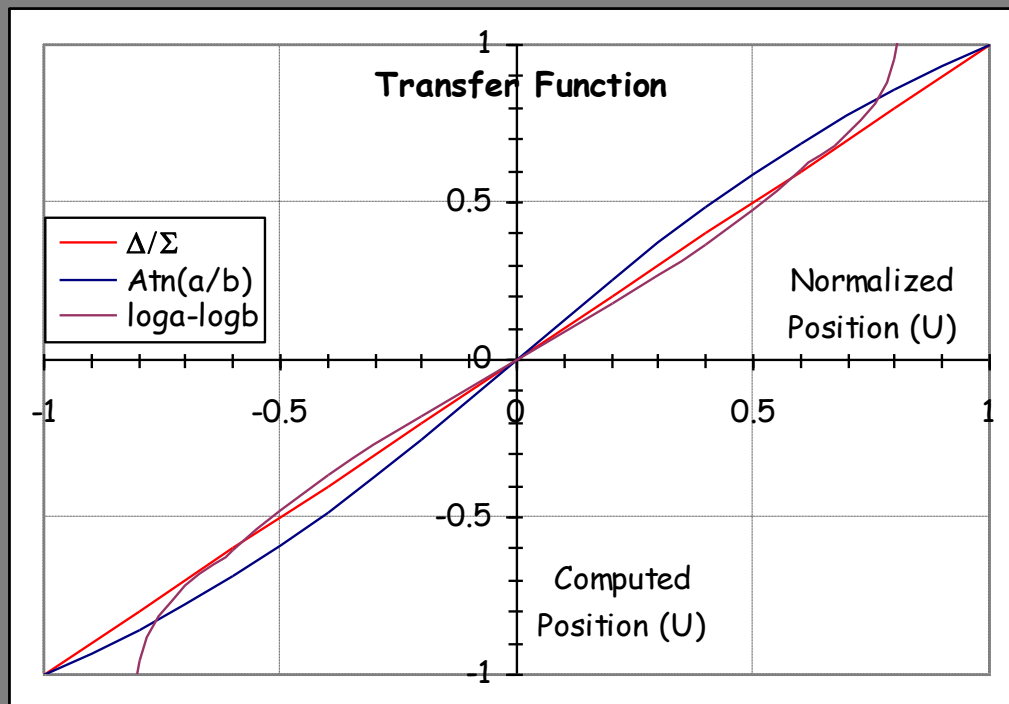
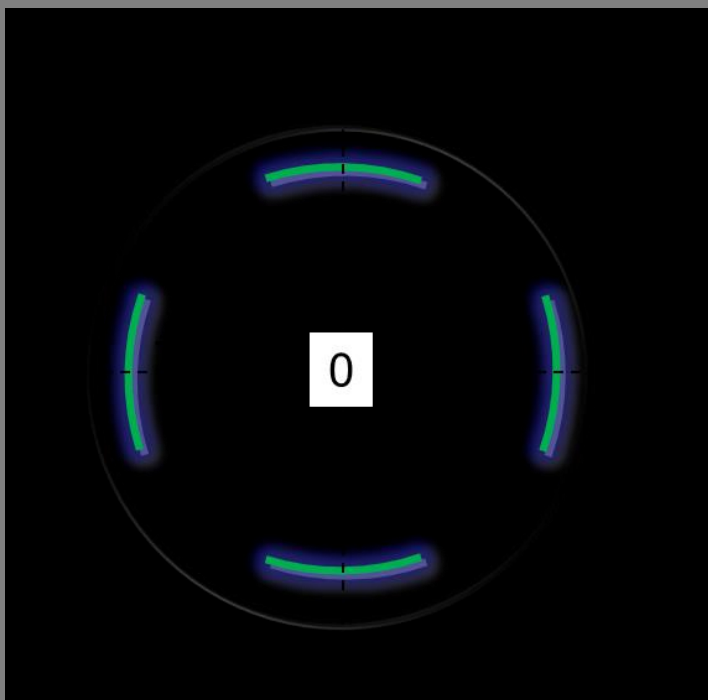
Example LHC:  $\varnothing$  24 mm, half aperture  $a=25$  mm, installed inside cryostat  
Critically:  $50\ \Omega$  matching of button to standard feed-through.



From C. Boccard, C. Palau-Montava et al.(CERN).

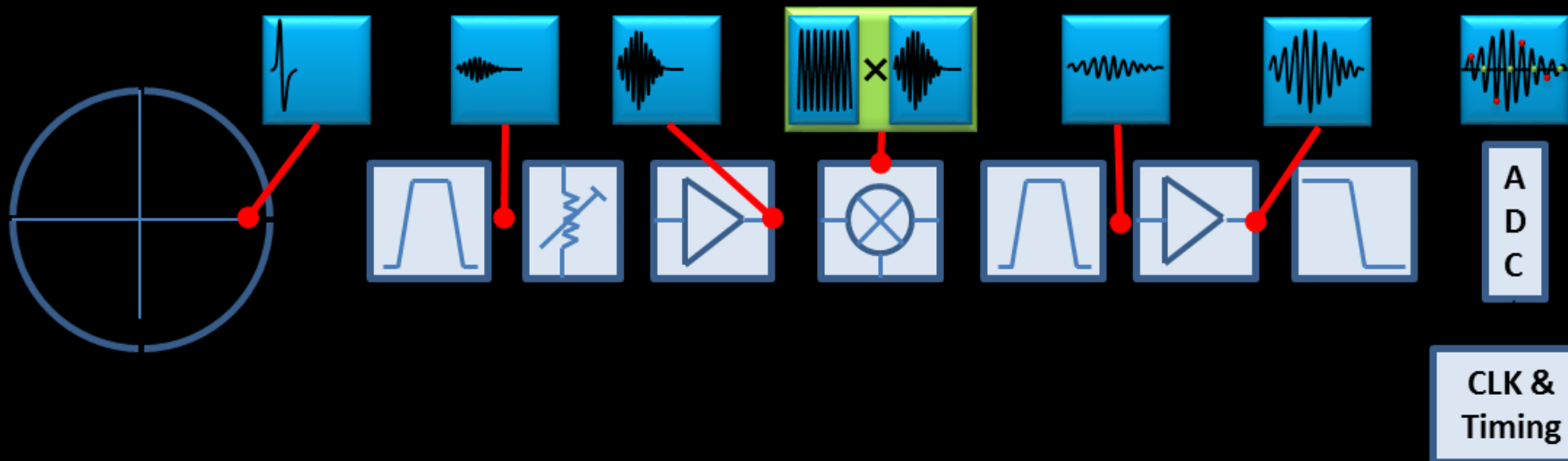
# Normalising the Position Reading

- To make it independent of intensity
- 3 main methods:
  - Difference/Sum :  $(V_A - V_B) / (V_A + V_B) = \Delta / \Sigma$
  - Phase :  $\text{Arctan}(V_A / V_B)$
  - Logarithm :  $\text{Log}(V_A) - \text{Log}(V_B)$



# Modern BPM Read-out Electronics

- **Based on the individual treatment of the electrode signals**
  - Use of frequency domain signal processing techniques
    - Developed for telecommunications market
  - Rely on high frequency & high resolution analogue to digital converters
    - Minimising analogue circuitry
    - Frequency down-conversion used if necessary to adapt to ADC sampling rate
    - All further processing carried out in the subsequent digital electronics





# Orbit Acquisition

Thu Oct 18 13:20:30 2001

Start Tasks Operation SPS Top10 EDUMP Reset P2 Reset Active Tasks Exit

SPS\_orbit

QUIT SPS XORBIT V9.01/2K+1 Done Info

Acquire Reference Orbit Reference Catalog Send Correction

MON & COD no reference set no date Cancel Correction

Acquisition Time Load Orbit Difference Sum Skeleton

Closed Orbit dp/p-offset shown Control Plane Hor Vert MD Specials

Settings & Specials Reject at 3.0 sigma MICADO Other Tools

```

Loading correct TWISS file...
Reading Twiss ft_inj_v2001...
Initializing Twiss for 724 elements
724 elements copied to Twiss

CLOSED ORBIT : 18/10/2001 13:19:12
SC = 946 PROTON [# 59855]
MOMENTUM - 14.00 GeV
TWISS - ft_inj_v2001
GAIN/TIME = 0 / 1000 ms
AVERAGE = 1
DP/P - 0.16 permill

Data stored in /usr/opt/orbit/hpslx
  
```

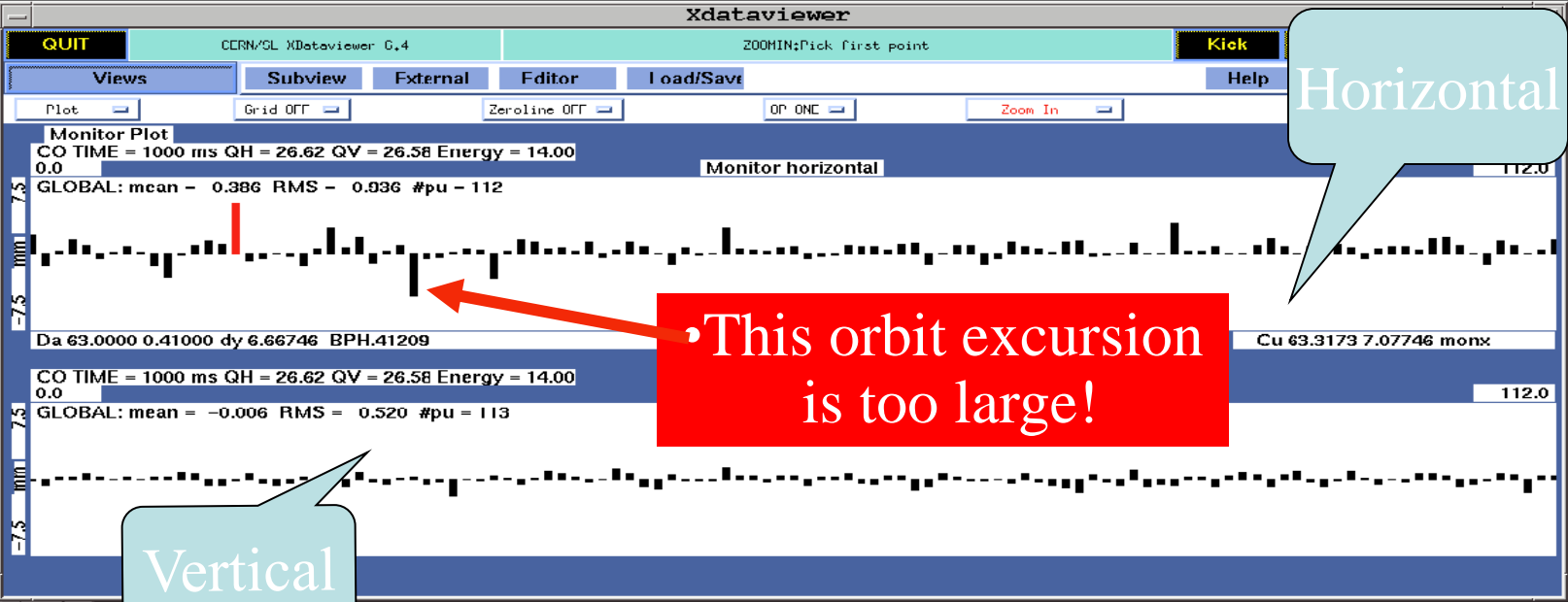
SPS\_Selection

File Supercycle Help

Running SC 946 Proton 1

Proton 1 0 - 9420ms (9420ms)

Ready.







# Orbit Correction (Operator Panel)

Thu Oct 18 13:24:30 2001

Start Tasks   Operation   SPS Top10   EDUMP Reset   P2 Reset   Active Tasks   **Exit**

---

**SPS\_orbit**

<b>QUIT</b>	SPS XORBIT V9.01/2K+1	Done	Info
Acquire	Reference Orbit	Reference Catalog	Send Correction
MON & COD	no reference set no date		Cancel Correction
Acquisition Time	Load Orbit	Difference	Sum
Closed Orbit	dp/p-offset shown	Control Plane <span style="background-color: #ff0000; color: white; padding: 2px;">Hor</span> <span style="background-color: #ff0000; color: white; padding: 2px;">Vert</span>	
Settings & Specials	Reject at 3.0 sigma	MICADO	Other Tools

**SPS\_Selection**

File   Supercycle   Help

Running SC 946  
Proton 1

Proton 1  
0 - 9420ms (9420ms)

Ready.

**Xdataviewer**

CERN/SL Xdataviewer 6.4   ZOOMIN:Pick first point   Kick Clean Reverse

Views   Subview   External   Editor   Load/Save   Help   Select

Plot   Grid OFF   Zerolinc OFF   OP ONE   Zoom In   Box

18/10/01 13:29:45

**Predicted Correction Results**

0.0   Before Correction   112.0

GLOBAL: mean = -0.006 RMS = 0.520 #pu = 113

---

Da 56.0000 0.2700 dy -1.3117 BPV.33509   Cu 55.9502 -1.0417 mon

0.0   Difference   112.0

GLOBAL: mean = 0.023 RMS = 0.328 #pu = 113

---

Da 26.0000 0.40381 dy 5.63786 BPV.21509   Cu 25.5858 6.04167 diff

0.0   After Correction   112.0

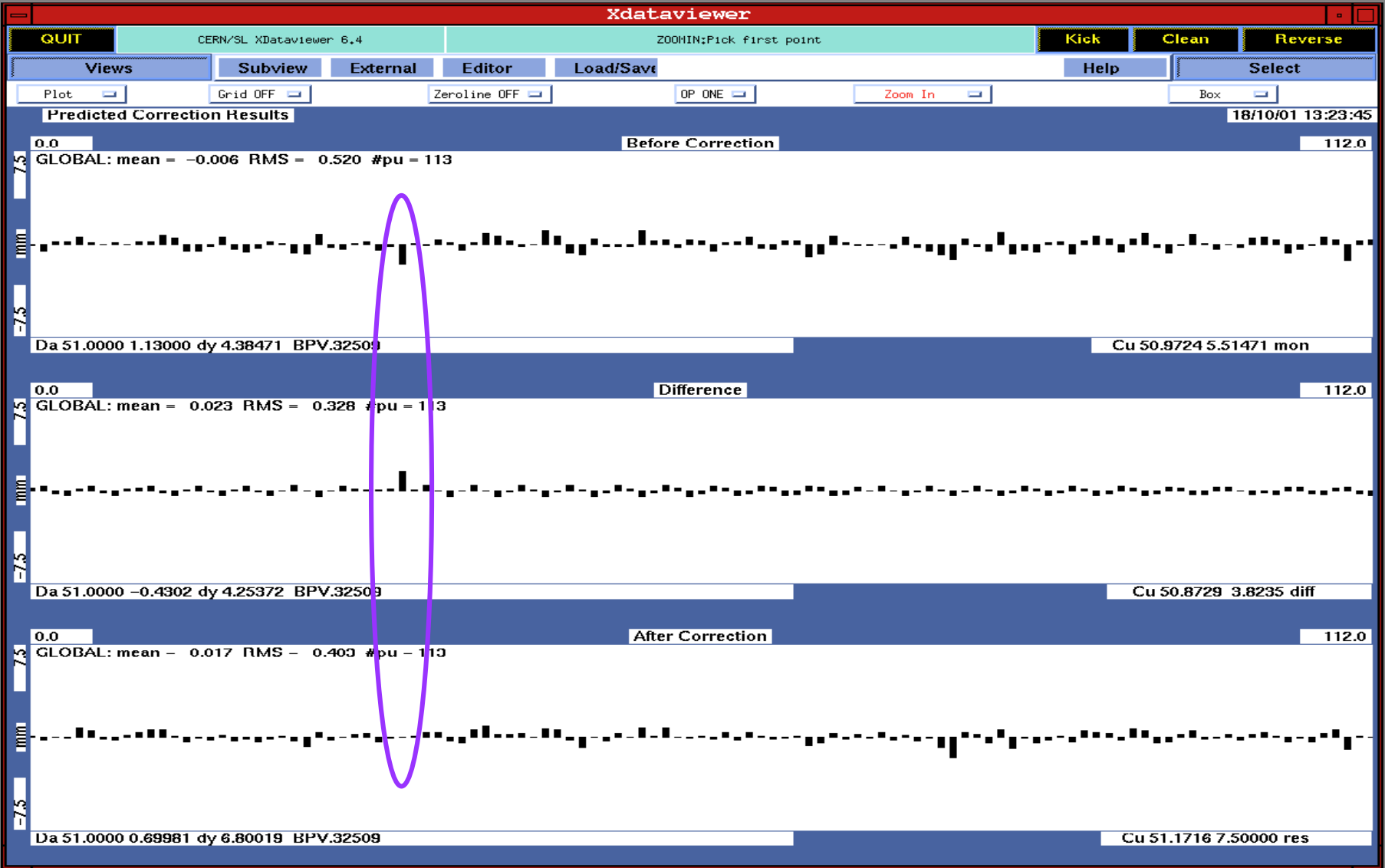
GLOBAL: mean = 0.017 RMS = 0.403 #pu = 113

---

Da 4.00000 0.73520 dy -0.7352 BPV.10909   Cu 3.88267 0.00000 res



# Orbit Correction (Detail)





# Beam Threading

- Threading the beam round the LHC ring (very first commissioning)
  - One beam at a time, one hour per beam.
  - Collimators were used to intercept the beam (1 bunch,  $2 \times 10^9$  protons)
  - Beam through 1 sector (1/8 ring)
    - correct trajectory, open collimator and move on.

Beam 2 threading

BPM availability ~ 99%

YASP DV LHCRING / INJ-TEST-NB / beam 2



## Kind of boring: orbit corrections....but:

---

Beam physics data derived from BPM rawdata:

Examples:

orbit difference for different beam momenta → dispersion

Orbit difference for different beam intensities → Transverse impedance of vacuum chamber

Turn by turn trajectory on each BPM; beam forced on constant oscillation → Beta function and phase advances



# The Typical Instruments

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- Beam Intensity
  - beam current transformers
- Beam Position
  - electrostatic or electromagnetic pick-ups and related electronics
- **Beam Profile**
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
  - ionization and luminescence monitors
  - femtosecond diagnostics for ultra short bunches
- Beam Loss
  - ionization chambers or pin diodes
- Machine Tune and Chromaticity (derived quantities)

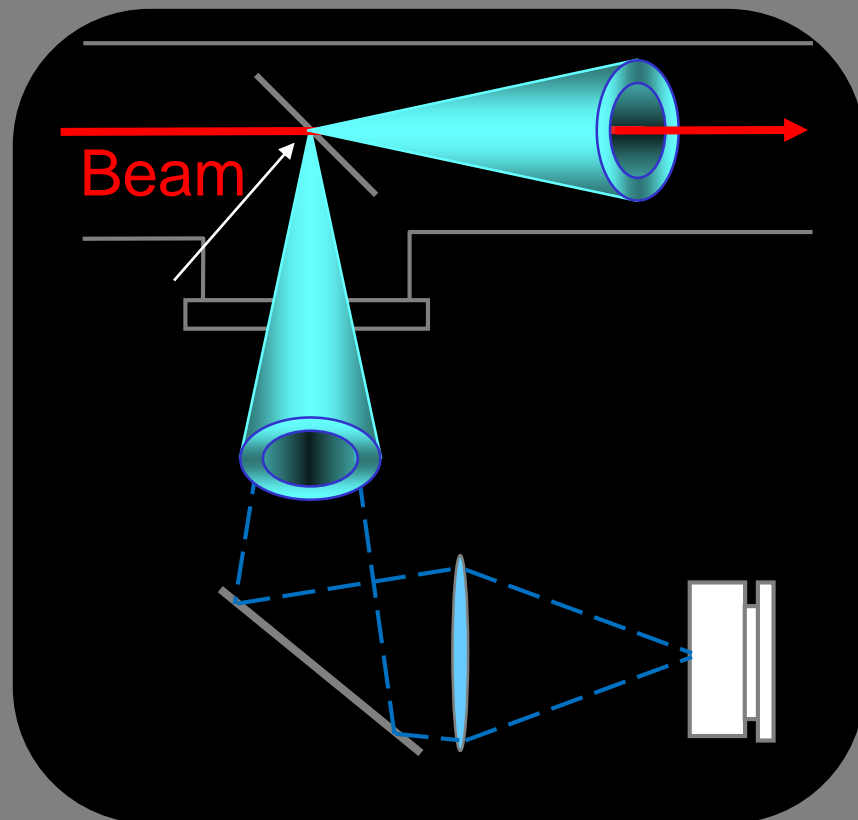
# Beam Profile Monitoring using Screens

- **Screen Types**

- Luminescence / Scintillating Screens
  - Destructive (thick) but work with low intensities
- Optical Transition Radiation (OTR) screens
  - Much less destructive (thin) but require higher energy / intensity beam

- **OTR**

- Radiation emitted when a charged particle goes through an interface with different dielectric constants
- Surface phenomenon allows use of very thin screens ( $\sim 10\mu\text{m}$ )
  - Can use multiple screens with single pass in transfer lines
  - Can leave it in for hundreds of turns e.g. for injection matching



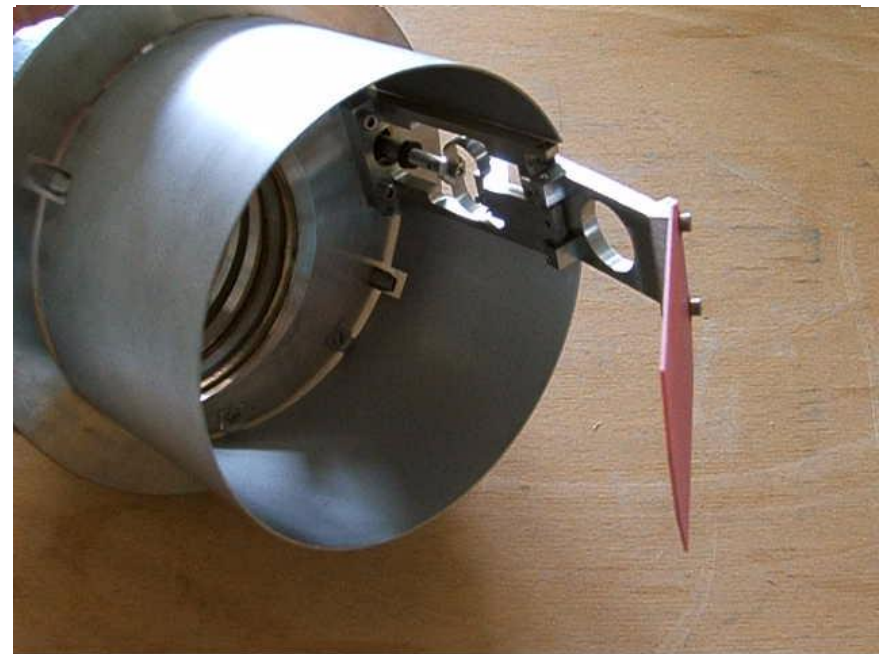




# Screen mechanism

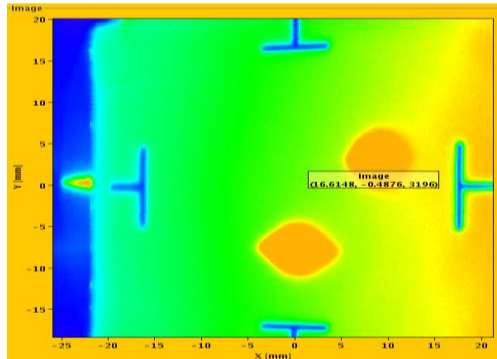


- Screen with graticule

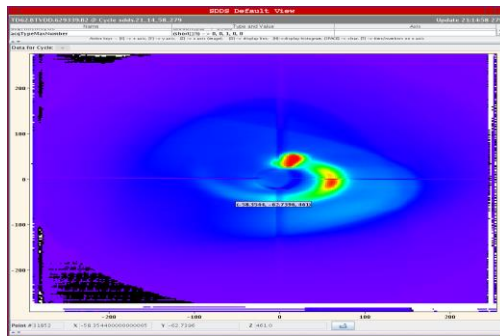




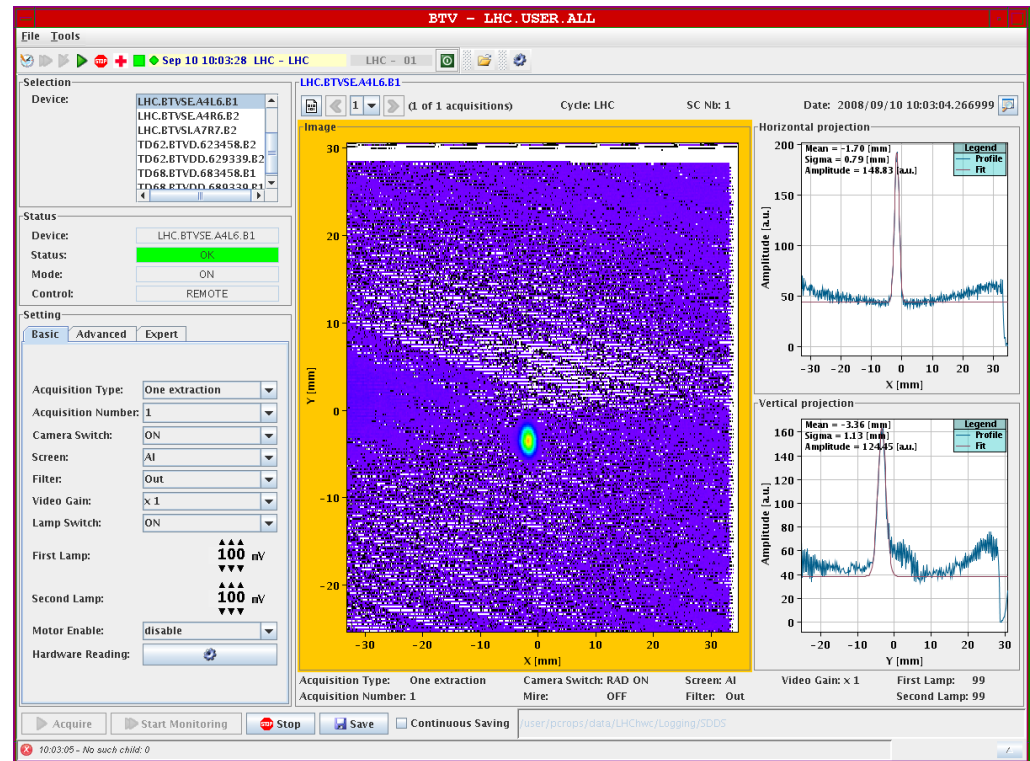
# Results from TV Frame grabber



First full turn  
as seen by the  
BTV  
10/9/2008



Un-captured  
beam sweeps  
through the  
dump line



- For further evaluation the video signal is digitized, read-out and treated by program



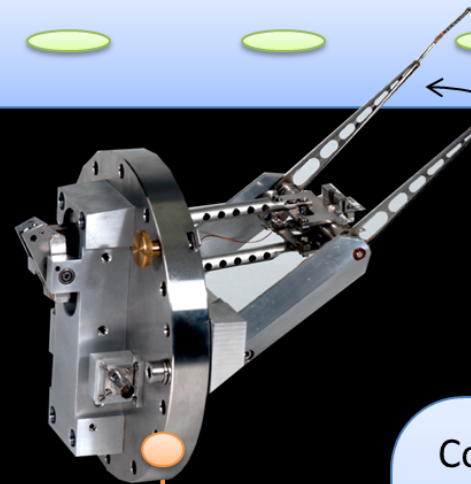


# Beam Profile Monitoring using Wire-Scanners

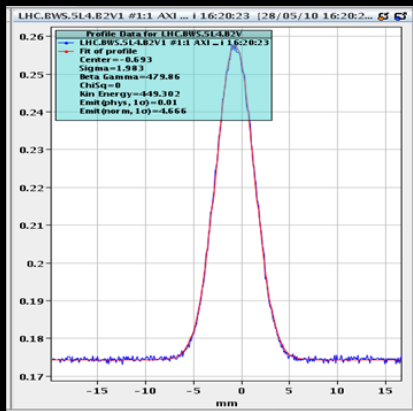
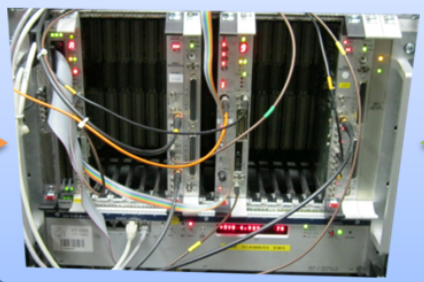
Vacuum tube

Particle beam

Secondary Particles generated by beam interactions with the wire

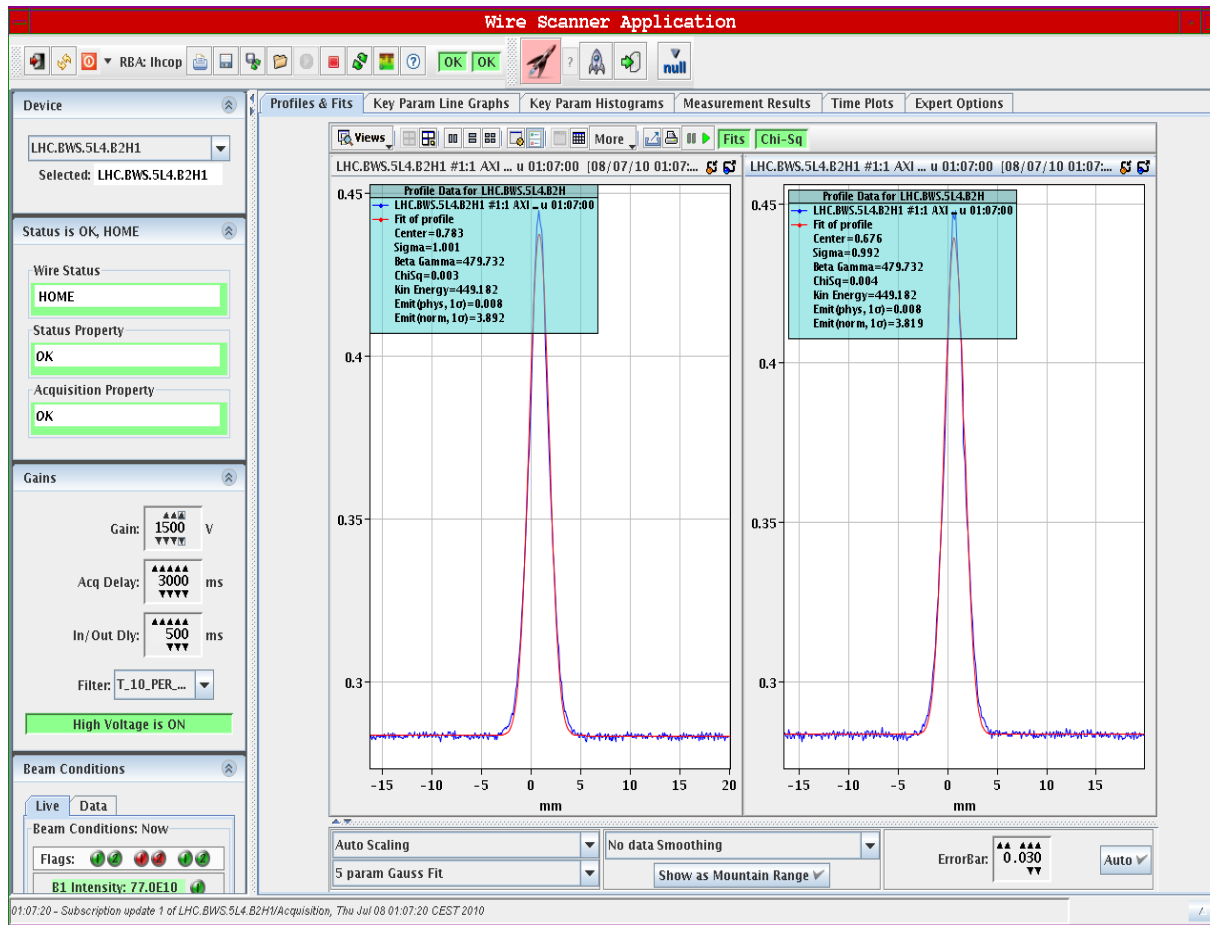


Control and acquisition Electronics





# Wire scanner profile



High speed needed because of heating.

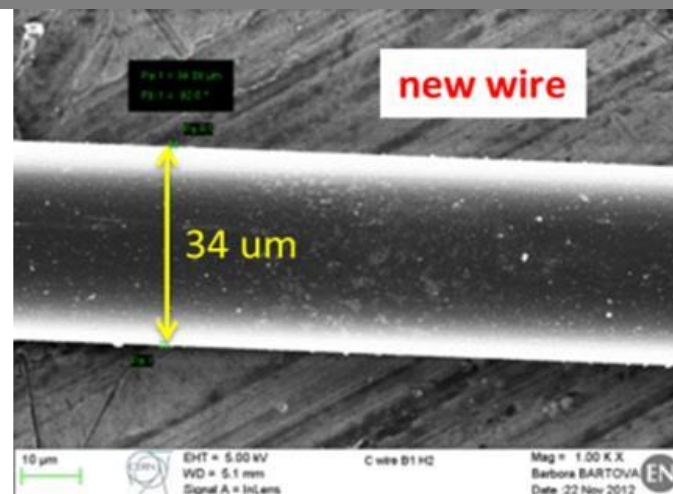
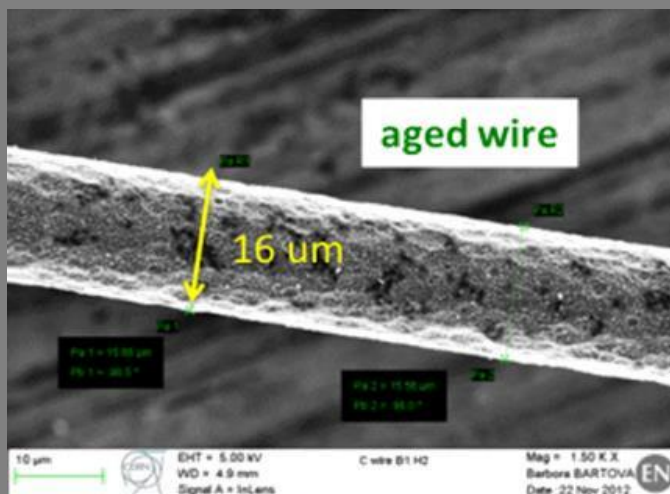
Adiabatic damping

Current increase due to speed increase

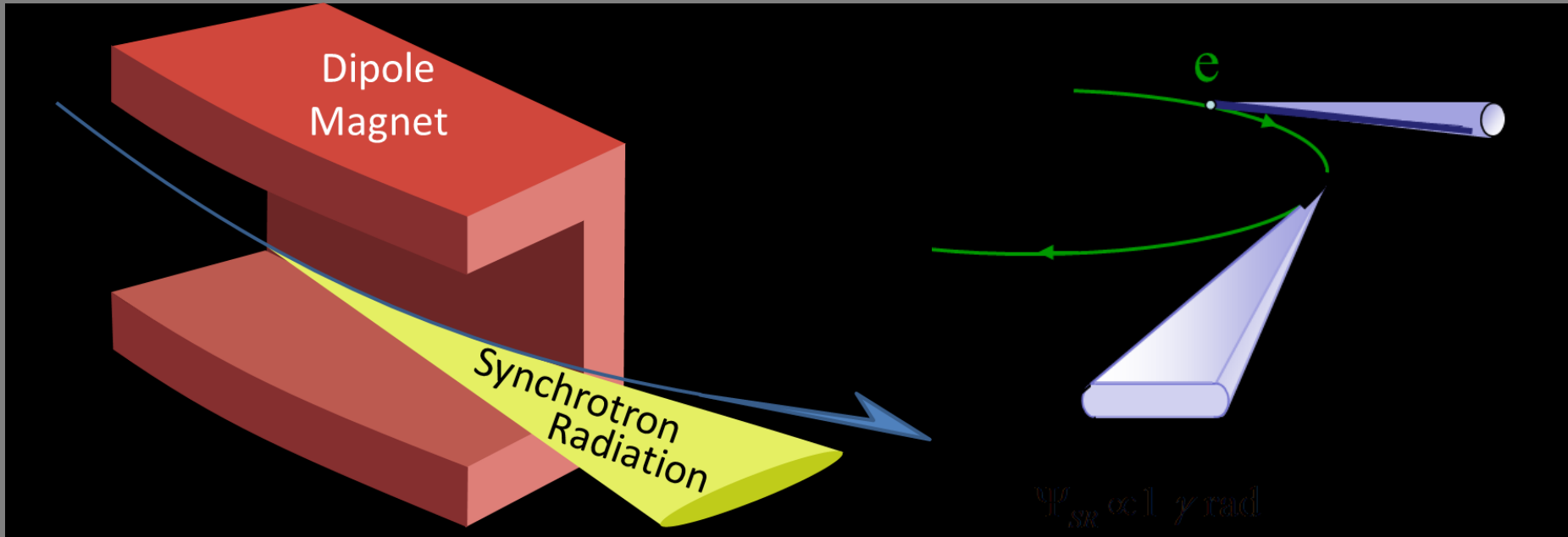
Speeds of up to 20m/s  
=> 200g acceleration

# Limitation of WireScanners

- **Wire Breakage – why?**
  - Brittle or Plastic failure (error in motor control)
  - Melting/Sublimation (main intensity limit)
    - Due to energy deposition in wire by proton beam
- **Temperature evolution depends on**
  - Heat capacity, which increases with temperature!
  - Cooling (radiative, conductive, thermionic, sublimation)
    - Negligible during measurements (Typical scan 1 ms & cooling time constant ~10-15 ms)
- **Wire Choice**
  - Good mechanical properties, high heat capacity, high melting/sublimation point
  - E.g. Carbon which sublimates at 3915K



# Synchrotron Light Monitors



- **Synchrotron light**

- Emitted from a moving charge bent in a magnetic field
- The main “raison d’être” for light sources
- Also a very useful, non-invasive, powerful diagnostic tool
- Can even be observed with protons & lead ions in the LHC

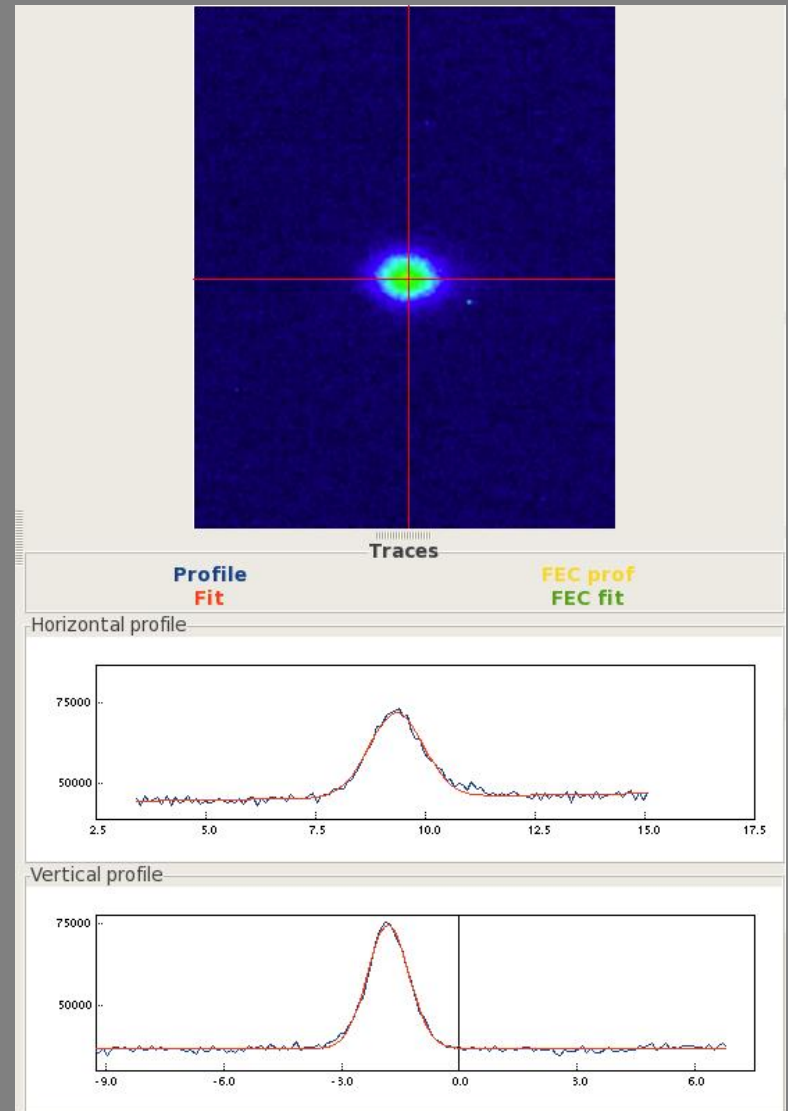
# Synchrotron Light Imaging

- Proton Beam Example

- LHC single bunch  
~ $1.1e11p$  @ 3.5 TeV
- Acquisition accumulated over 4 turns at 200Hz

- Limitations

- Aberrations
  - Mitigated by careful design
- Diffraction
  - Need to go to shorter wavelengths as the beam size becomes smaller





# Measuring Ultra Short Bunches

- Next Generation FELs & Linear Colliders

- Use ultra short bunches to increase brightness or improve luminosity

- How do we measure such short bunches?

- Direct Observation

- Produce light & observe with dedicated instruments
    - Use of RF techniques
    - Use laser pulses and sampling techniques

- Indirect Calculation

- Reconstruct bunch length from frequency spectrum
      - Either directly from the bunch or through its radiation spectrum

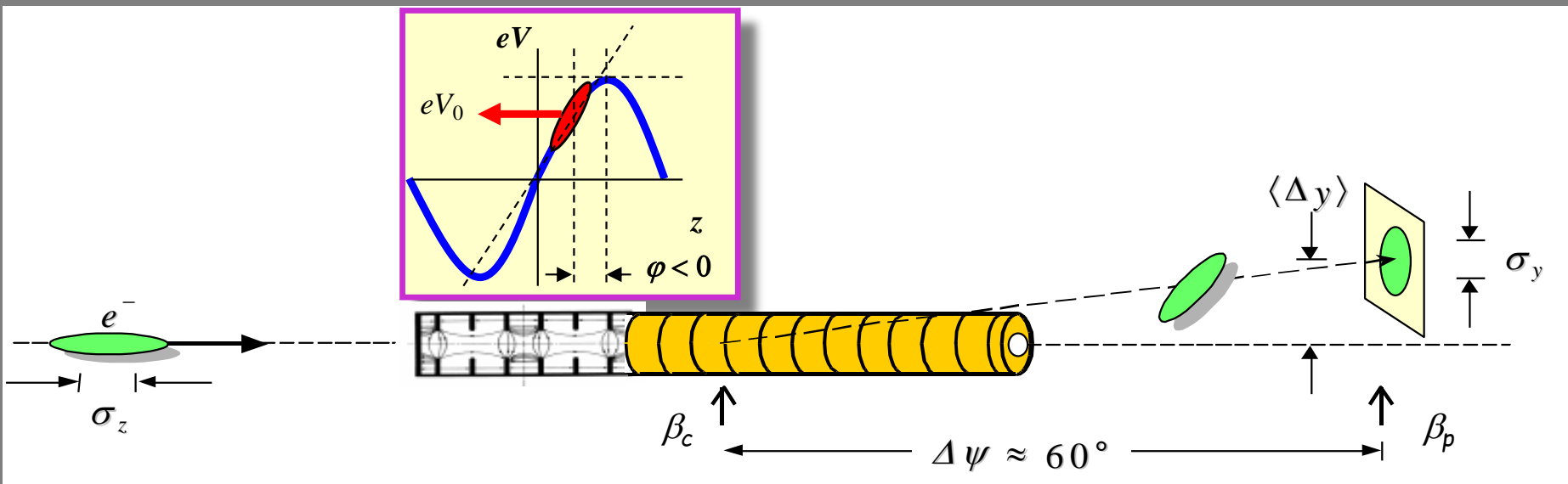
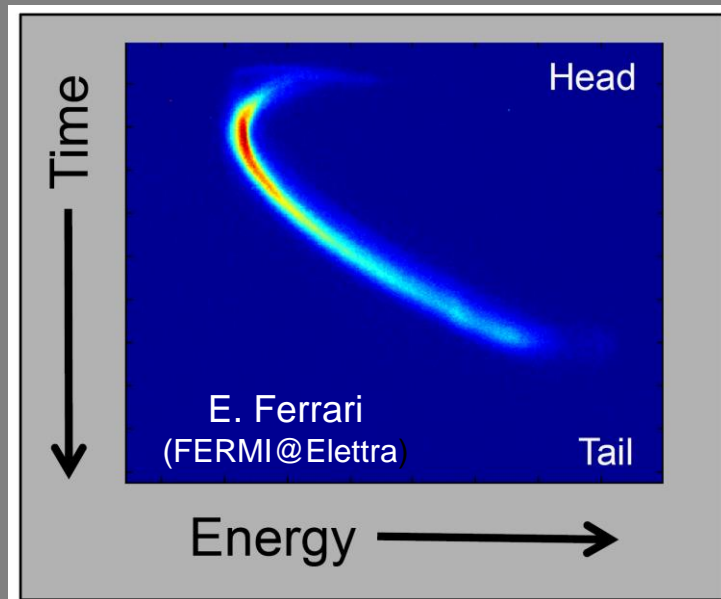
p <sup>+</sup> @ LHC	250ps
H <sup>-</sup> @ SNS	100ps
e <sup>-</sup> @ ILC	500fs
e <sup>-</sup> @ CLIC	130fs
e <sup>-</sup> @ XFEL	80fs
e <sup>-</sup> @ LCLS	<75fs

### Destructive Measurement

# Measuring Ultra Short Bunches

- RF Deflection

- Converts time information to spatial information
- Coupled to spectrometer also provides energy information
- Destructive technique
- Resolution down to 1.3 fs
  - X-band RF cavity
  - Linac Coherent Light Source (SLAC)





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# The Typical Instruments

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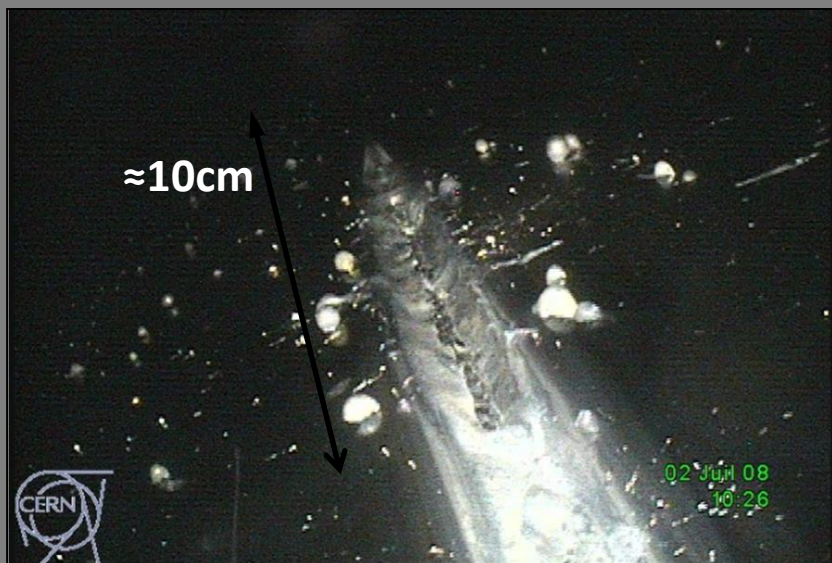
- Beam Intensity
  - beam current transformers
- Beam Position
  - electrostatic or electromagnetic pick-ups and related electronics
- Beam Profile
  - secondary emission grids and screens
  - wire scanners
  - synchrotron light monitors
  - ionization and luminescence monitors
  - femtosecond diagnostics for ultra short bunches
- **Beam Loss**
  - ionization chambers or pin diodes
- Machine Tune and Chromaticity (derived quantities)

# Beam Loss Detectors

- **Role of a BLM system:**
  - Protect the machine from damage
  - Dump the beam to avoid magnet quenches (for SC magnets)
  - Diagnostic tool to improve the performance of the accelerator
- **E.g. LHC**

Stored Energy	
Beam 7 TeV	2 x 362 MJ
2011 Beam 3.5 TeV	above 2 x 100 MJ

Quench and Damage at 7 TeV	
Quench level	$\approx 1 \text{ mJ/cm}^3$
Damage level	$\approx 1 \text{ J/cm}^3$



- **SPS incident**
  - June 2008
  - 2 MJ beam lost at 400GeV

# Beam Loss Detectors

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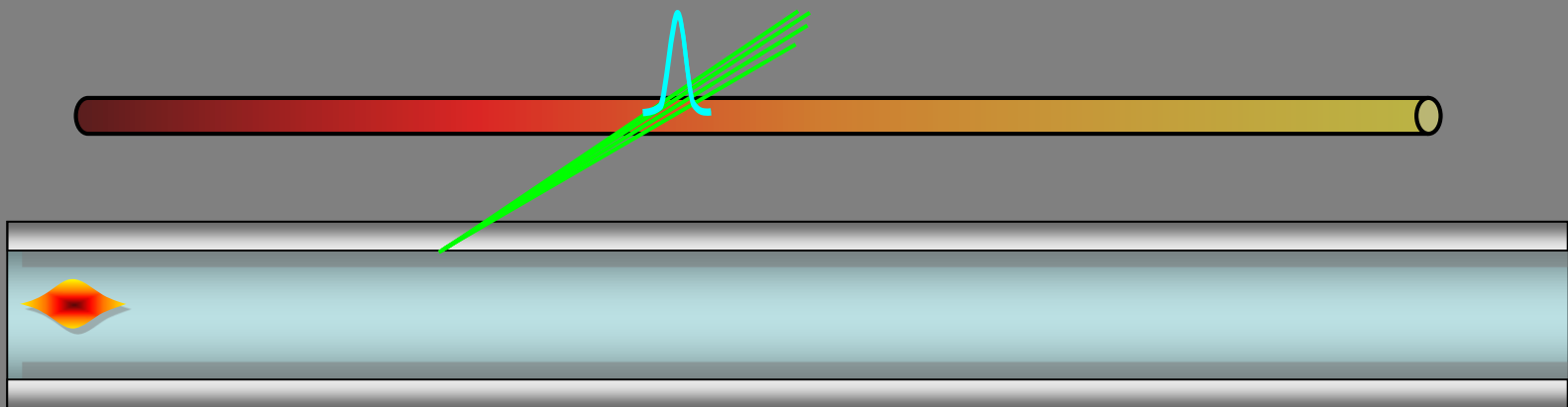
- Common types of monitor

- Long ionisation chamber (charge detection)

- Up to several km of gas filled hollow coaxial cables
- Position sensitivity achieved by comparing direct & reflected pulse
  - e.g. SLAC – 8m position resolution (30ns) over 3.5km cable length
- Dynamic range of up to  $10^4$

- Fibre optic monitors

- Electrical signals replaced by light produced through Cerenkov effect

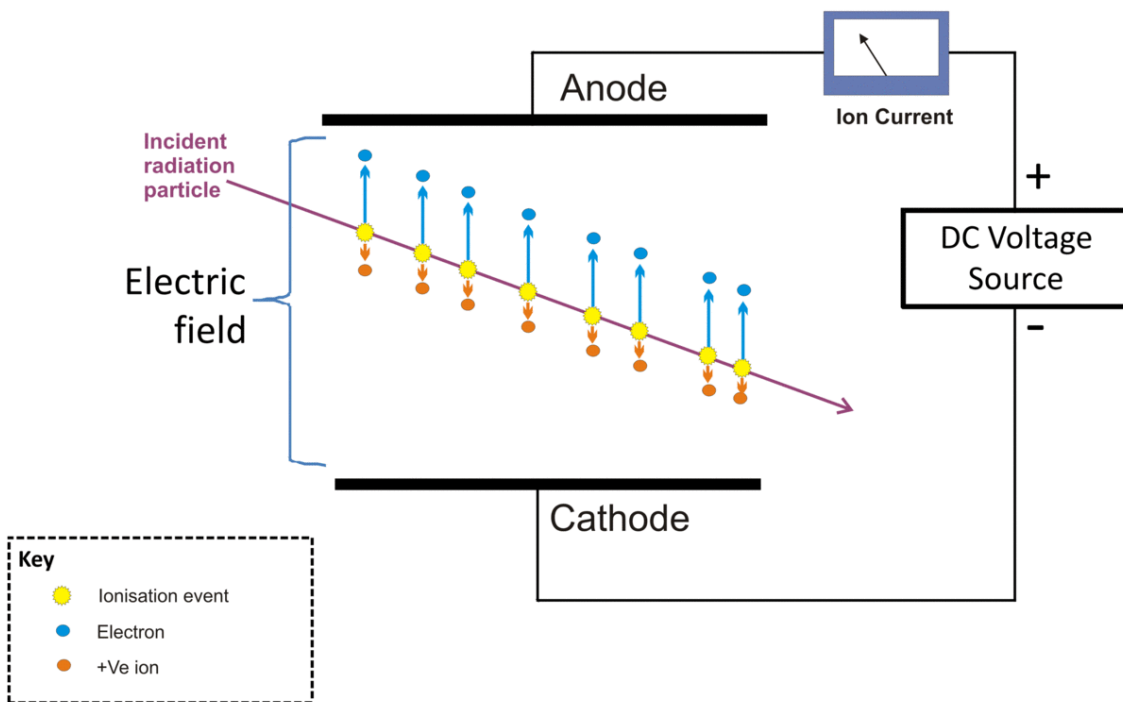


# Beam Loss Detectors

- Common types of monitor

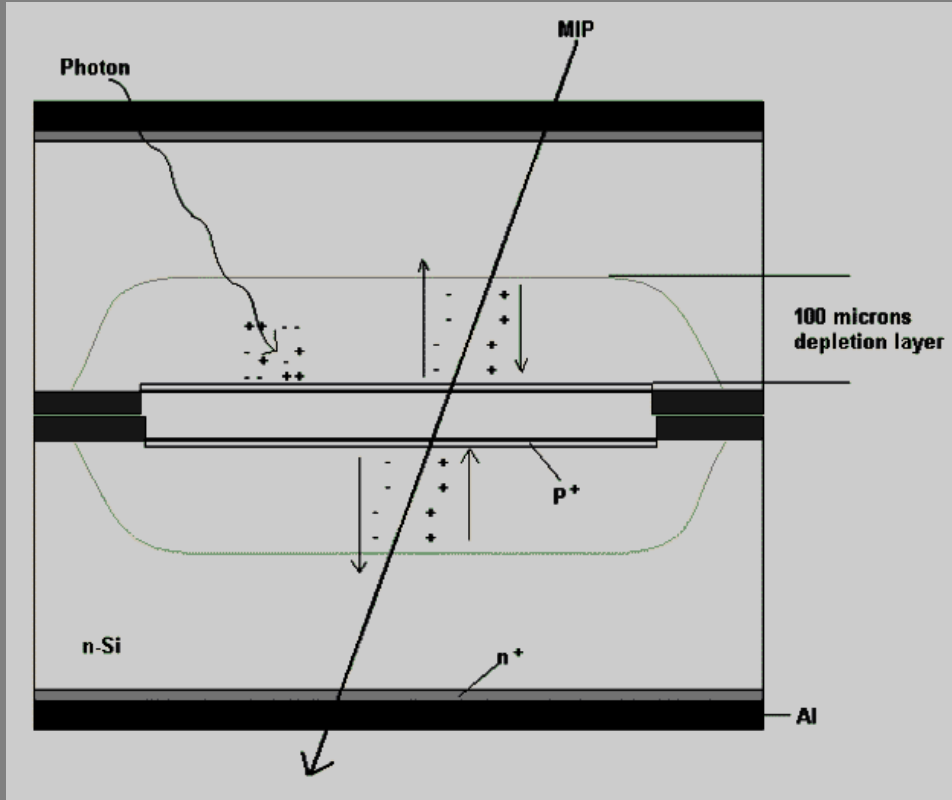
- Ionisation chambers
- Dynamic range of  $< 10^8$
- Slow response ( $\mu\text{s}$ ) due to ion drift time

## Visualisation of ion chamber operation



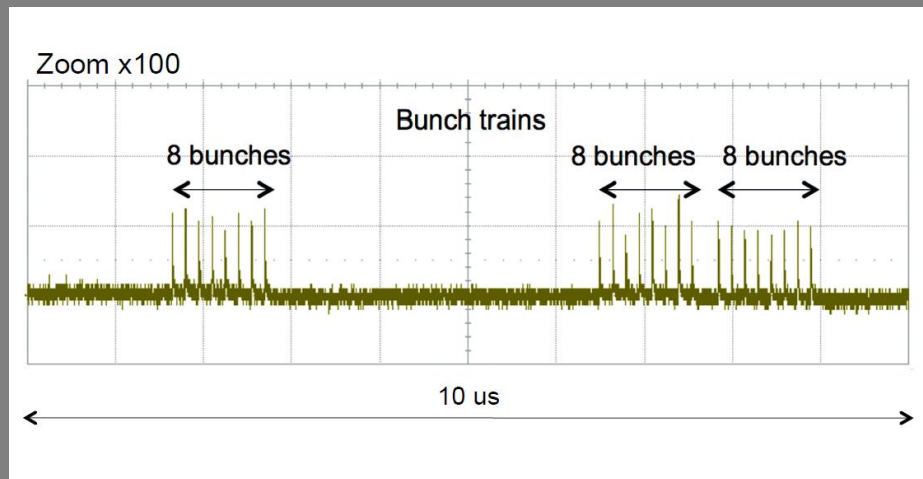
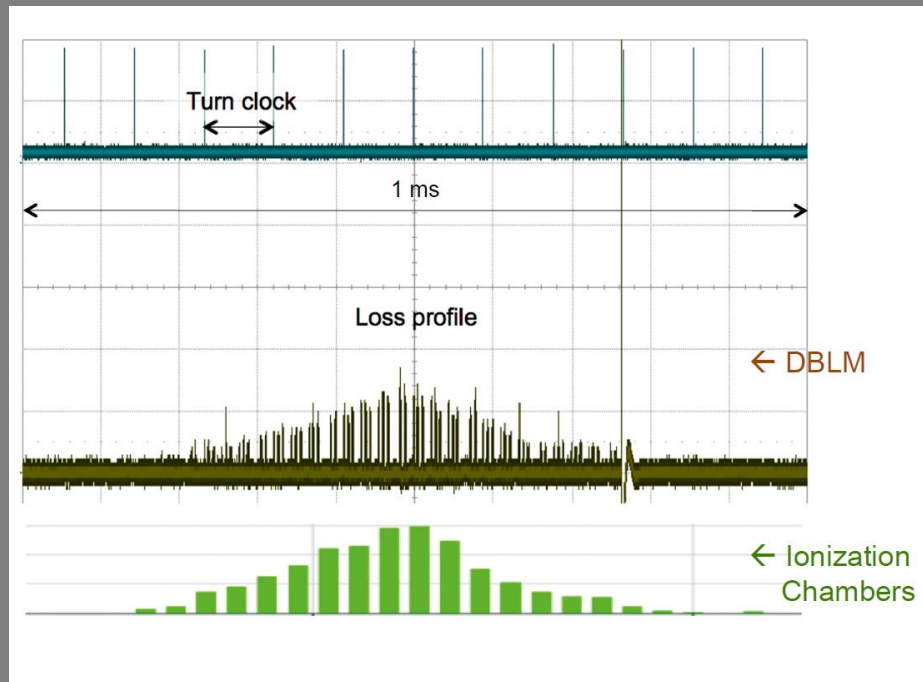
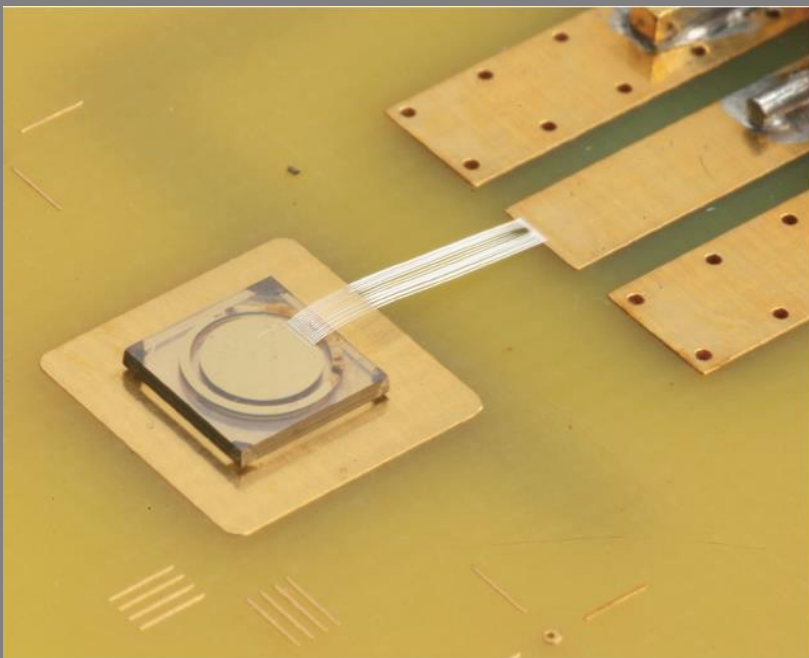
# Beam Loss Detectors

- Common types of monitor
  - PIN photodiode (solid state ionisation chamber)
    - Detect coincidence of ionising particle crossing photodiodes
    - Count rate proportional to beam loss with speed limited by integration time
    - Can distinguish between X-rays & ionising particles
    - Dynamic range of up to  $10^9$



# Beam Loss Detectors – New Materials

- **Diamond Detectors**
  - Fast & sensitive
  - Used in LHC to distinguish bunch by bunch losses
  - Investigations now ongoing to see if they can work in cryogenic conditions





# The Typical Instruments

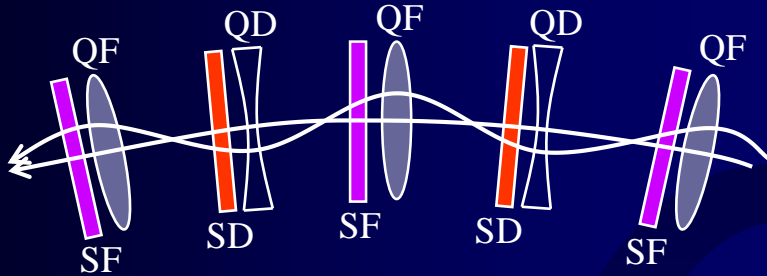
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# Measurement of Q (betatron tune)

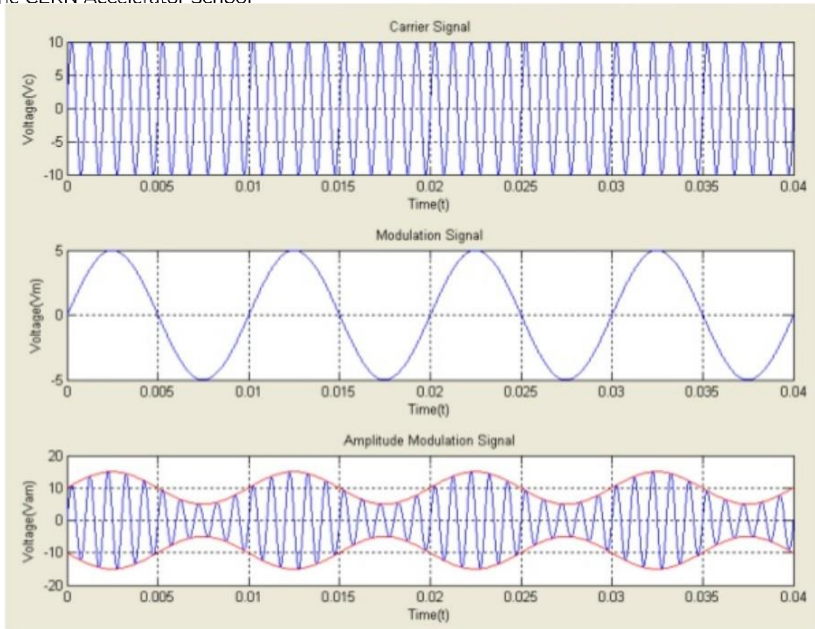


Characteristic Frequency  
of the Magnet Lattice  
Produced by the strength of the  
Quadrupole magnets

- **Q** – the eigenfrequency of betatron oscillations in a circular machine
  - One of the key parameters of machine operation
- **Many measurement methods available:**
  - different beam excitations
  - different observations of resulting beam oscillation
  - different data treatment



# Amplitude modulation



Using trigonometric identity:

$$(\sin a)(\sin b) = \frac{1}{2}[\cos(a-b) - \cos(a+b)]$$

$$v = V_c \sin 2\pi f_c t$$

$$+ \frac{m}{2} V_c \cos 2\pi(f_c - f_m)t$$

$$- \frac{m}{2} V_c \cos 2\pi(f_c + f_m)t$$

$$v_{AM} = V_c \sin 2\pi f_c t + \frac{V_m}{2} \cos 2\pi(f_c - f_m)t - \frac{V_m}{2} \cos 2\pi(f_c + f_m)t$$

↑  
Carrier

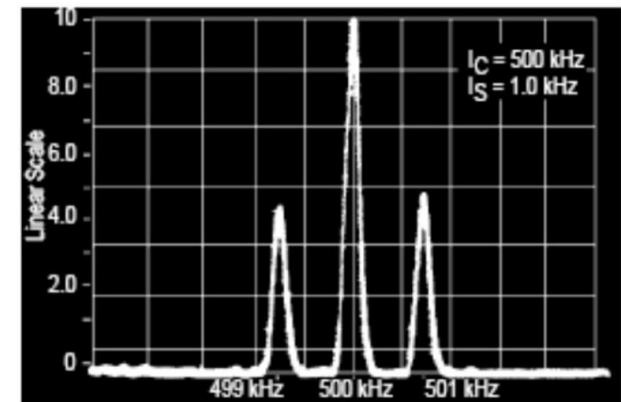
↑  
LSB

↑  
USB

$$v = V_{env} \sin 2\pi f_c t$$

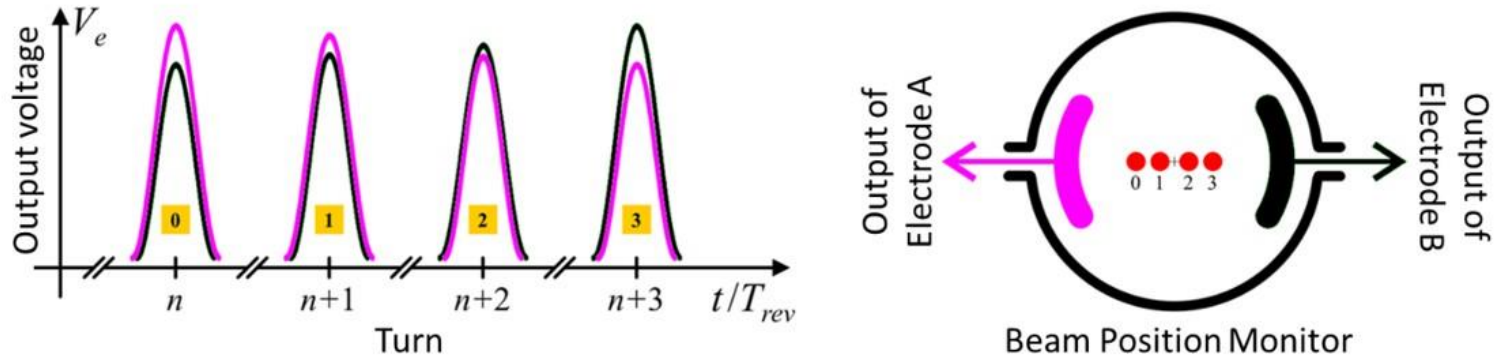
$$= V_c (1 + m \sin 2\pi f_m t) \bullet \sin 2\pi f_c t$$

m = modulation index 0...1 ( $V_{env} = V_c$ )



## Relevant example of amplitude modulation: stimulated betatron oscillation(or: tune measurement)

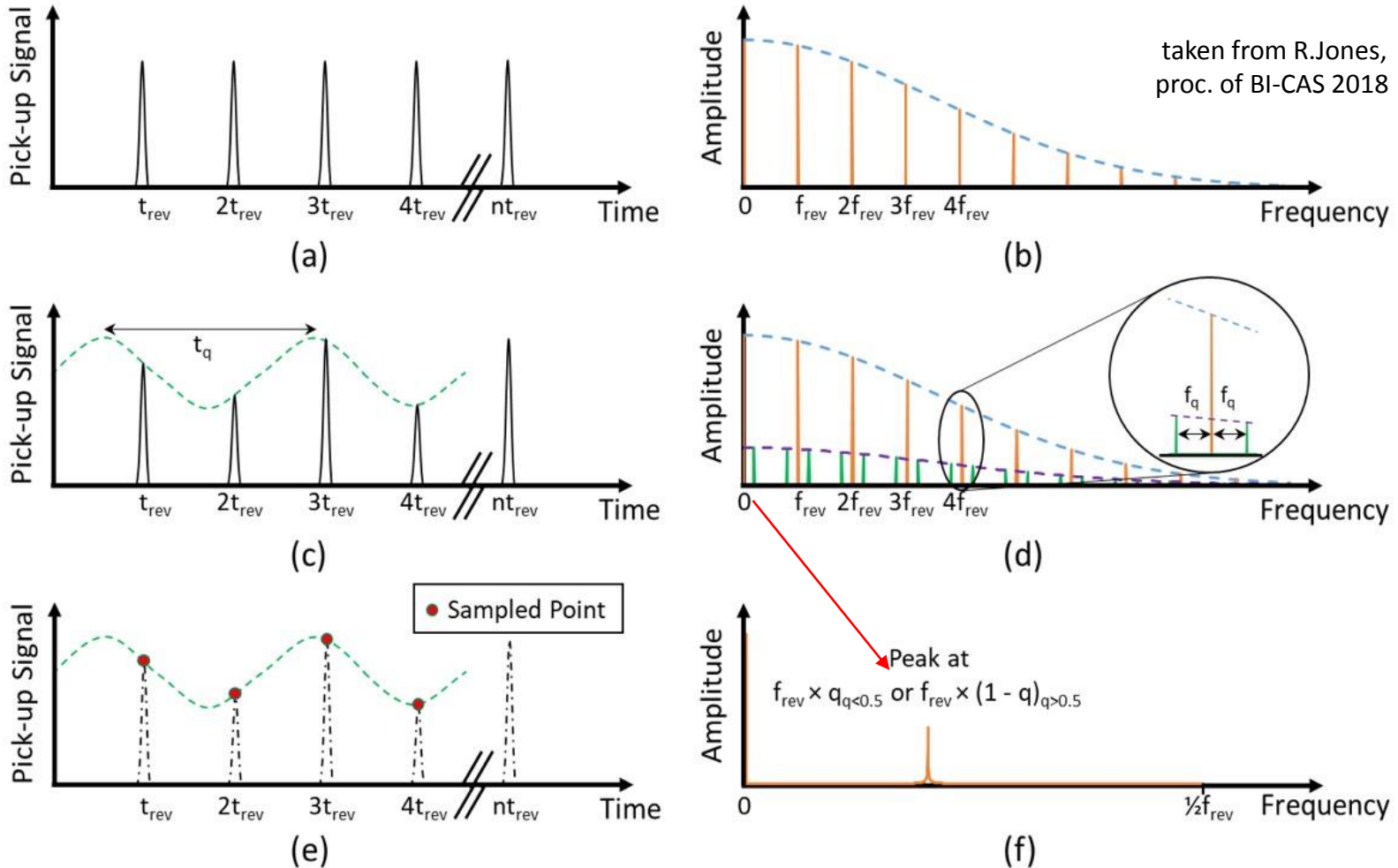
taken from R.Jones,  
proc. of BI-CAS 2018



**Fig. 4:** Detecting oscillations using a beam position monitor. The oscillation information is superimposed as a small modulation on a large intensity signal.

Beam centre of charge makes small betatron oscillation around the closed orbit  
(- stimulated by an exciter or by a beam instability)

Depending on the proximity to an EM sensor the measured signal amplitude varies.

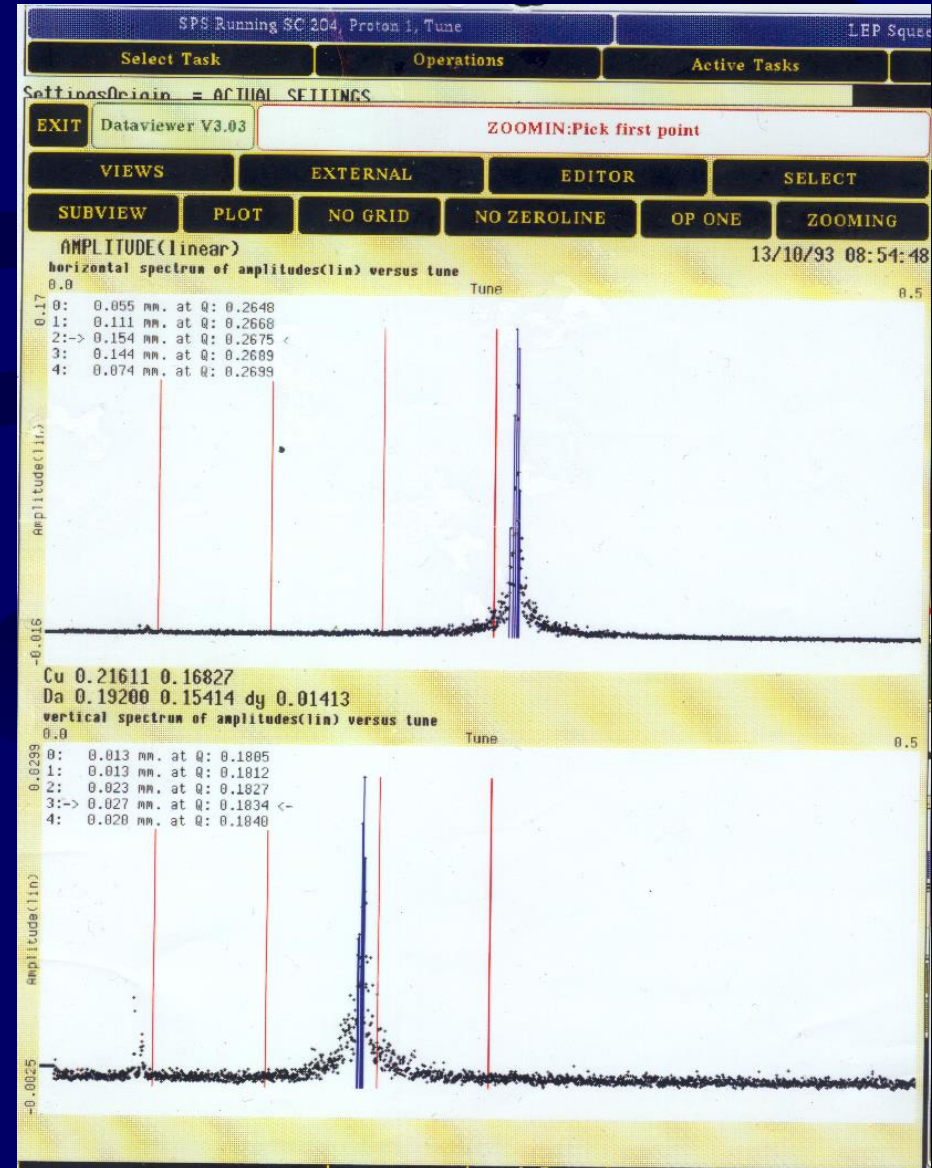
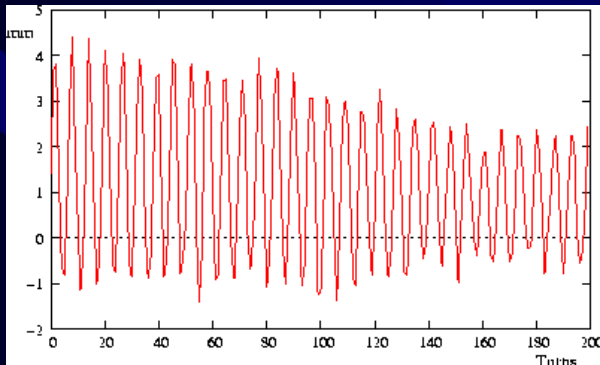


**Fig. 2:** Time and frequency domain representation for a bunch of particles observed at one single location on the circumference of the accelerator. (a & b) continuous measurement without betatron oscillation; (c & d) continuous measurement undergoing betatron oscillation (50% modulation); (e & f) sampled once per revolution.



# Fourier analysis of turn by turn BPM measurements

- 1) Stimulate transverse beam oscillation with a kicker magnet (short dipole kick during one revolution period)
- 2) Measure turn-by-turn beam position
- 3) Fourier transform of data
- 4) Tune: = maximum of frequency spectrum
- 5) Resolution:  $dq/q = 2/N_{\text{samp}}$
- 6) Problems:
  - single shot measurement
  - oscillation has to last during measurement
  - strong damping in some accelerators
  - large initial excitation (emittance growth in case of hadron beams)

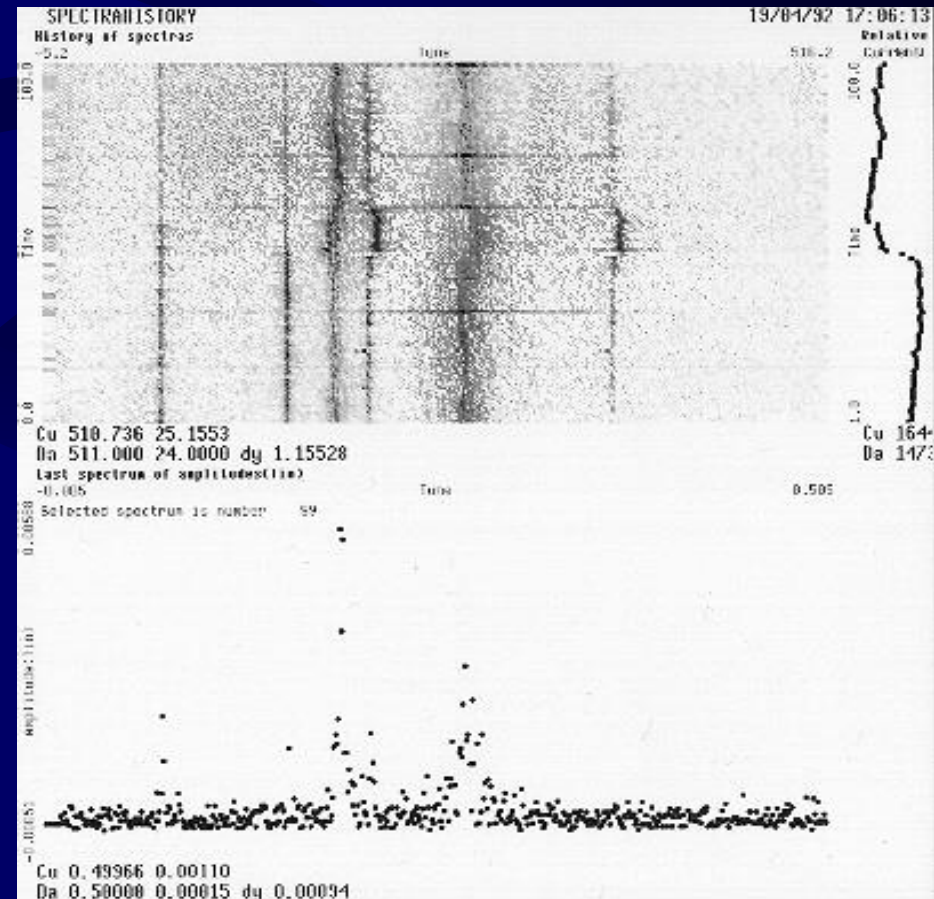
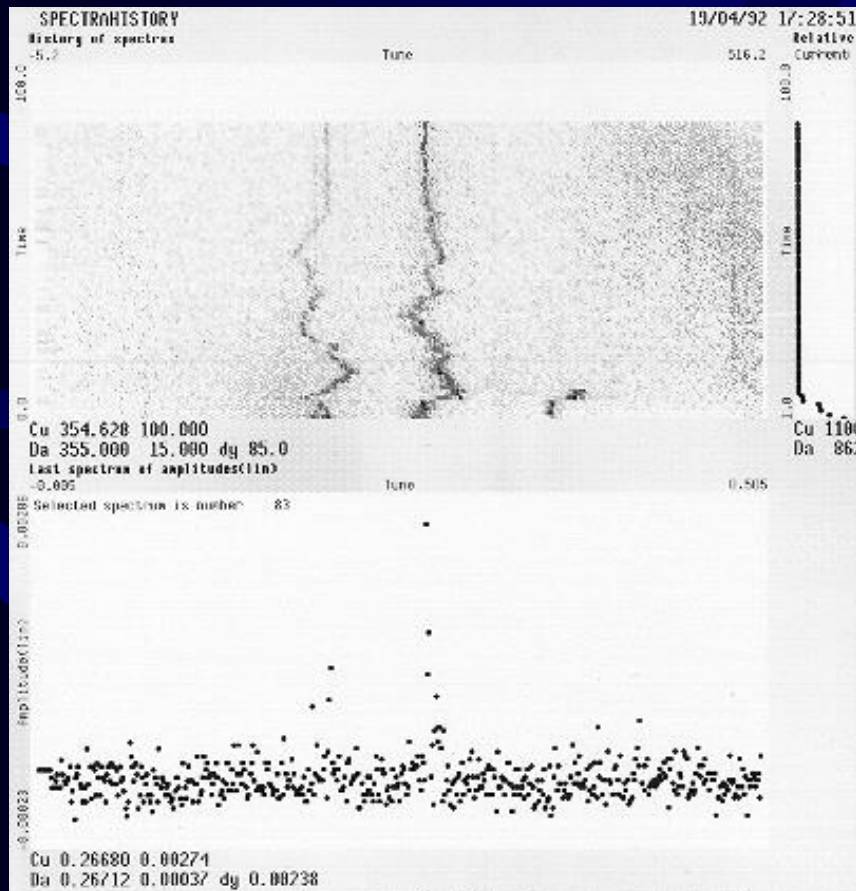






# Time Resolved Measurements

- To follow betatron tunes during machine transitions we need time resolved measurements. Simplest example:  
→ repeated FFT spectra as before (spectrograms)





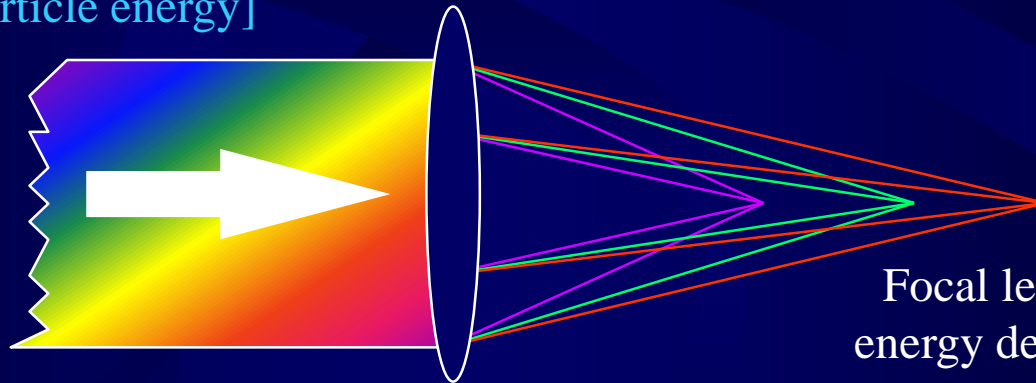
# Chromaticity ( $Q'$ or $\xi$ )

Spread in the Machine Tune  
due to Particle Energy Spread  
Controlled by Sextupole magnets

$$\Delta Q = Q' \frac{\Delta p}{p} = \left( \frac{1}{\gamma^2} - \alpha \right)^{-1} Q' \frac{\Delta f}{f}$$

## Optics Analogy:

Achromatic incident light  
[Spread in particle energy]



Lens

[Quadrupole]

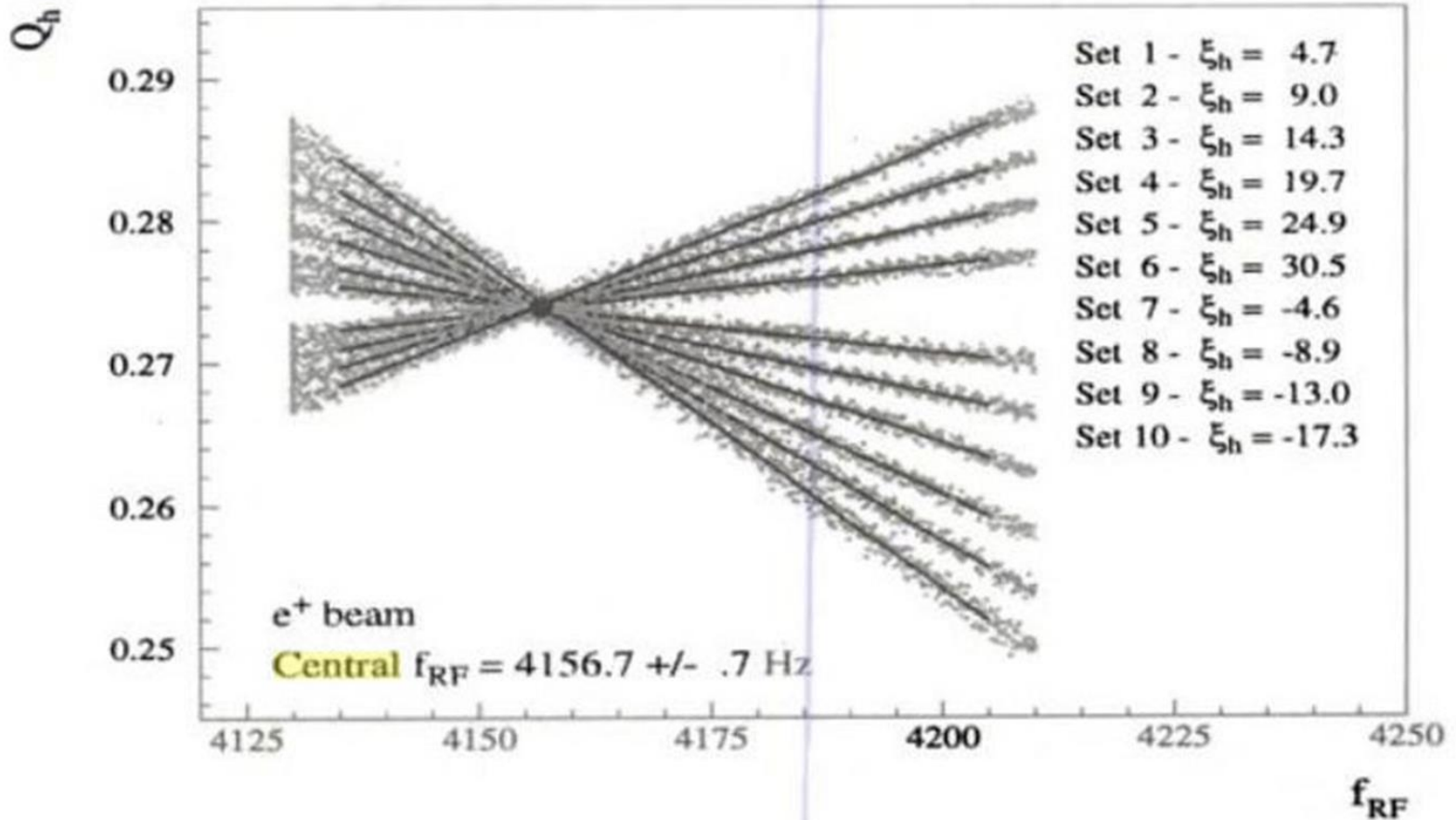
Focal length is  
energy dependent



# Chromaticity Measurements...

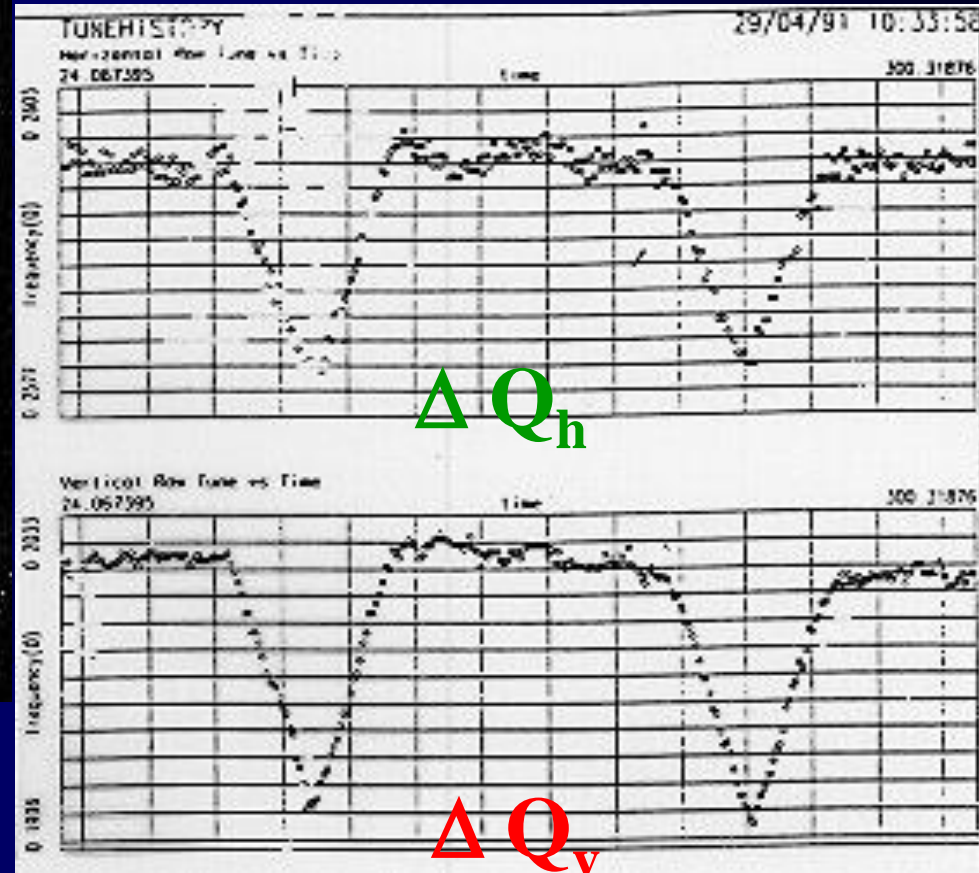
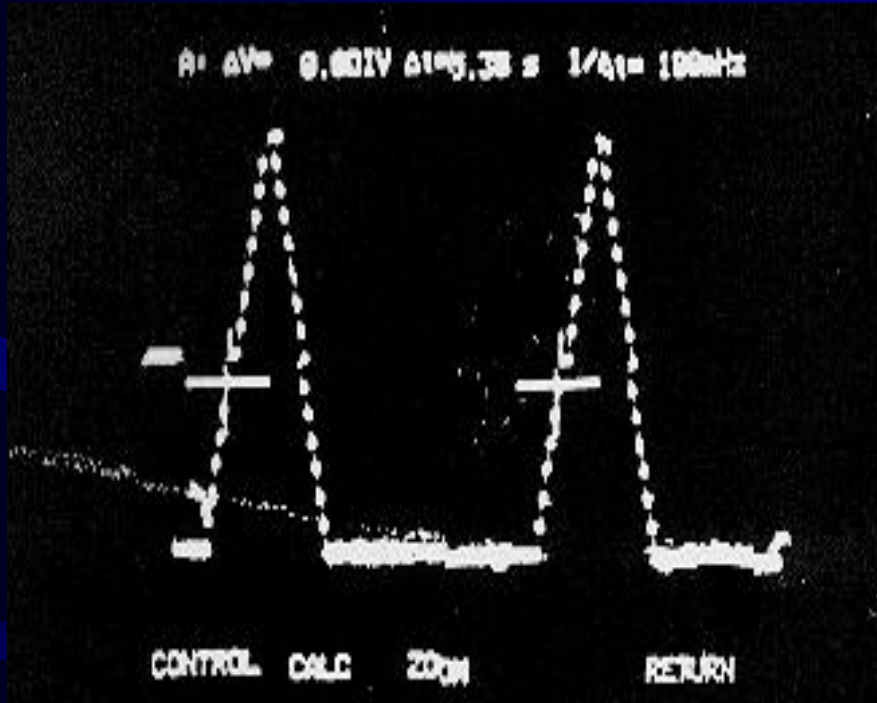
Simply by using the definition:

- Measure betatron tune for different beam momenta;
- vary beam momentum by changing the Rf-frequency





# Time resolved Q' Measurement



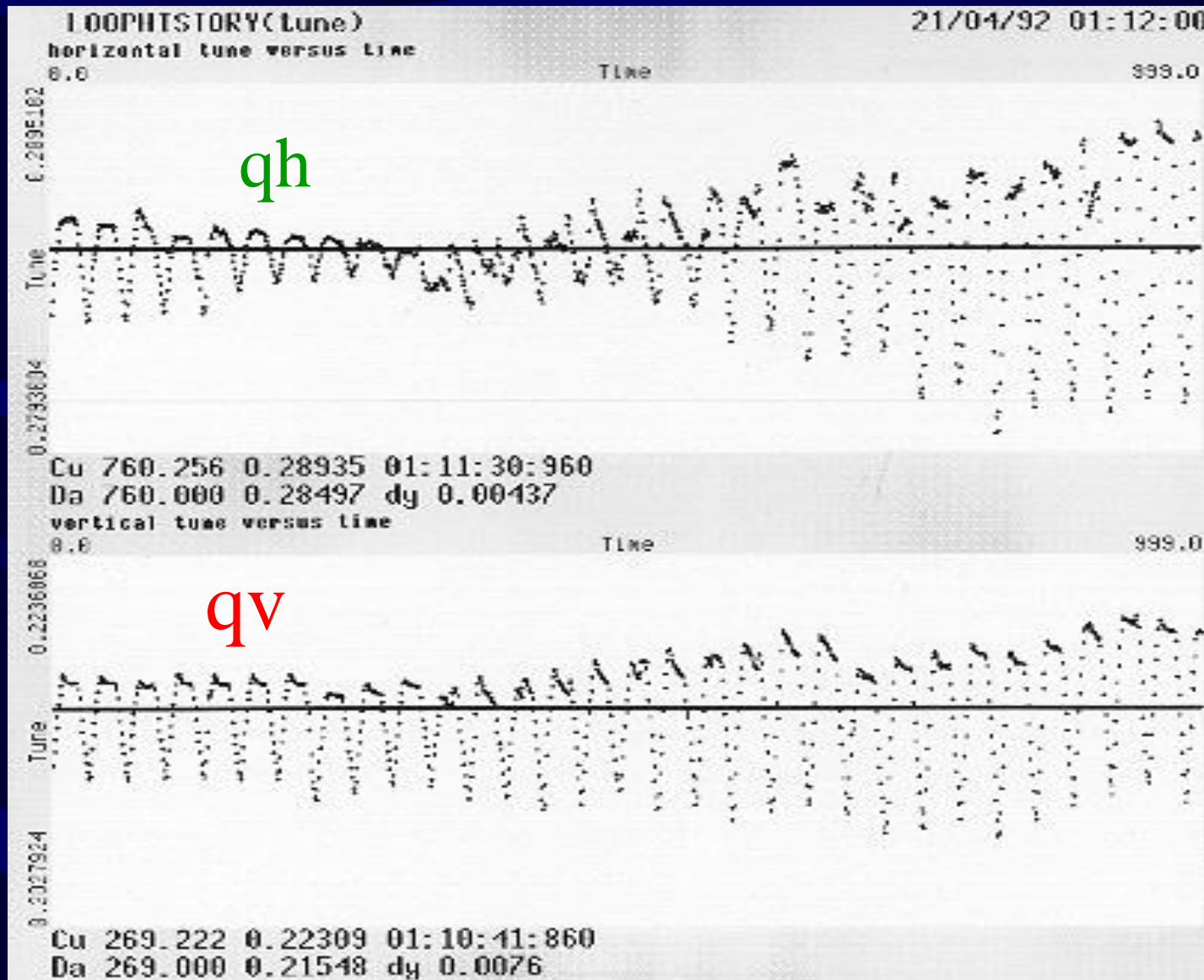
Applied Frequency Shift  
 $\Delta F$  (RF)

Amplitude & sign of chromaticity  
calculated from continuous tune plot





# Measurement Example during LEP $\beta$ -squeeze





# Last not least....

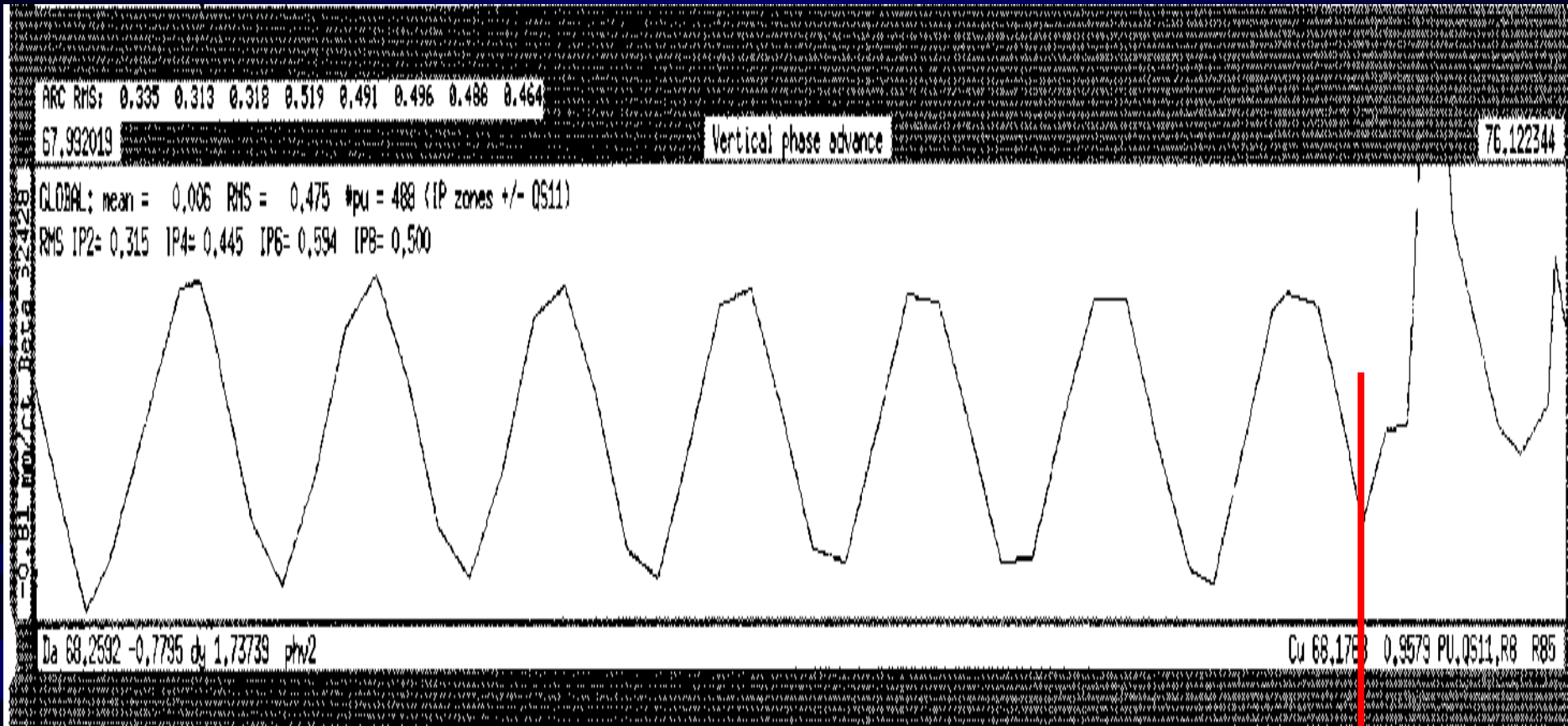
...a story from the good old days:

LEP after a technical stop

- no way to make the beam do one turn around the accelerator
- With BPM readings localize the problem to about 20 meters
- local check of equipment (quadrupole polarity...)
- radiography of beam pipe
  
- finally: cut beam pipe open



# LEP – No Circulating Beam after a technical stop

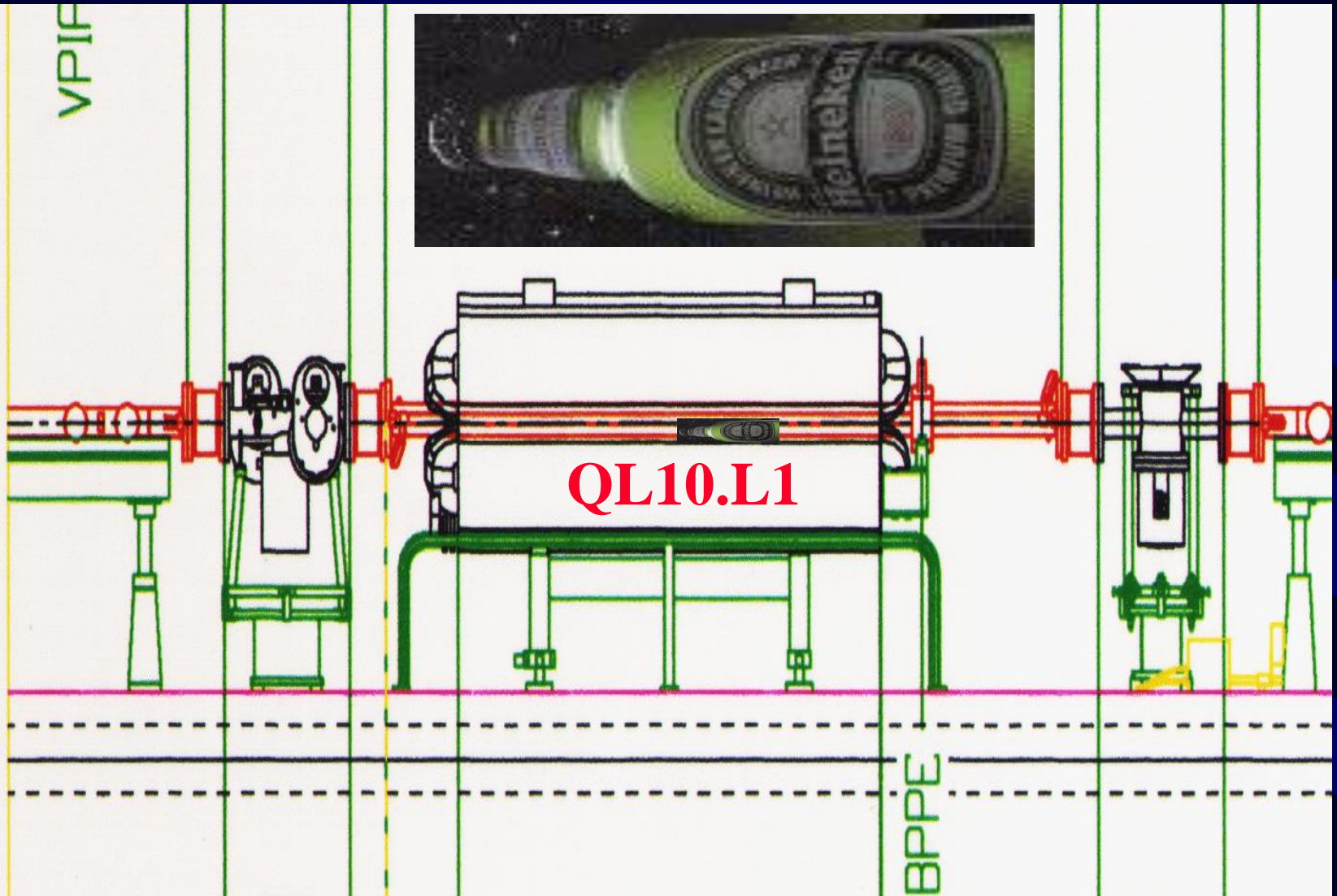


Positrons →

QL10.L1



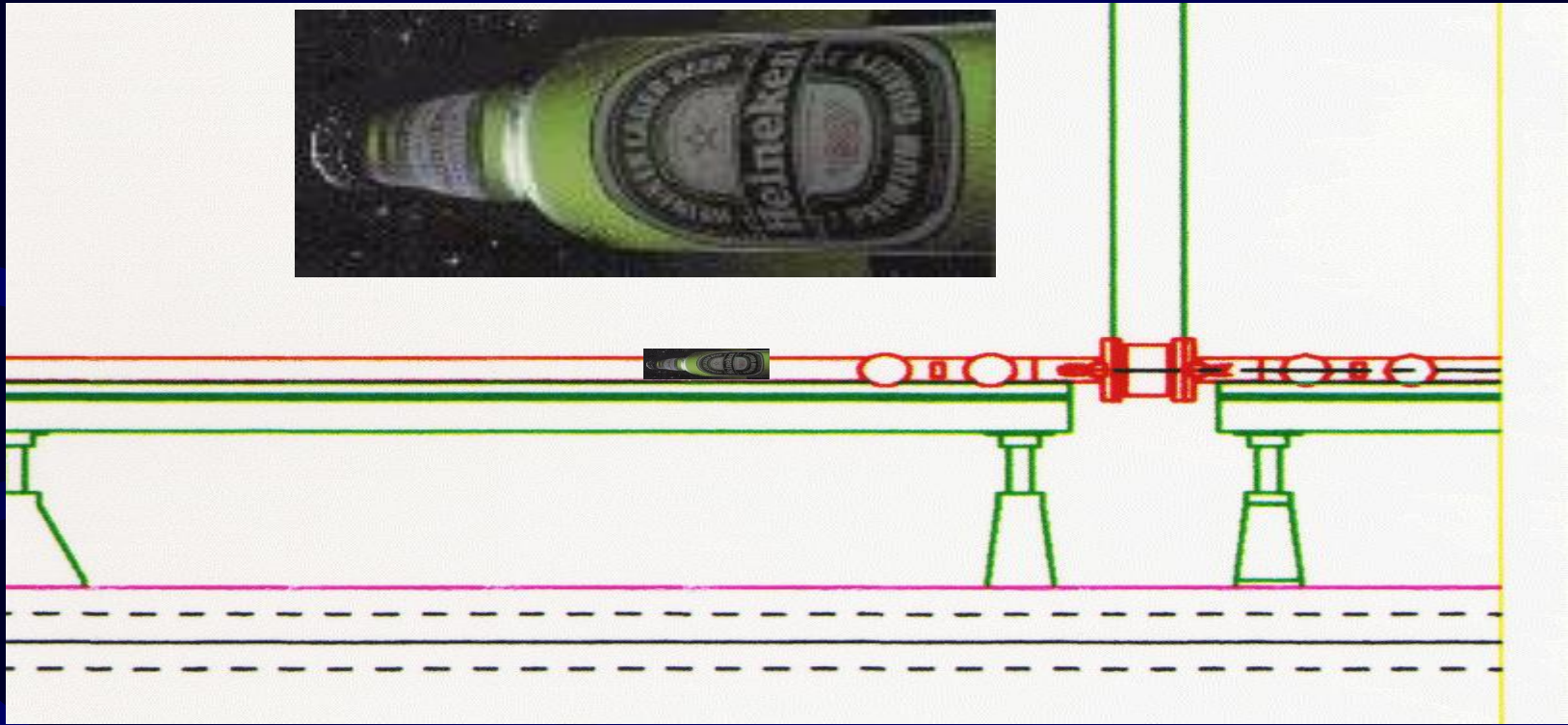
# Zoom on QL1







& 10 metres to the right ...



Unsociable sabotage: **both bottles were empty!!**